

AS39513

NFC Sensor Tag and Data Logger IC

General Description

The AS39513 is a semi-passive tag chip optimized for battery-powered smart labels with sensor functionality. The chip is ideal for applications using thin and flexible batteries but it also supports fully passive operation without a battery using the RF field from an RFID reader as a power source.

The RFID interface is fully ISO 15693 and NFC-V (T5T) compliant. External power can be supplied from a single-cell battery (typically 1.5V) or a dual-cell battery (typically 3V).

The chip has a fully integrated temperature sensor with a programmable temperature range (default -20°C to 55°C). The external sensor interface (S_{EXT}) is an analog input and allows the connection of an external sensor.

A real-time clock can be used to generate logging times and track the device lifetime. An SPI-like interface is available for chip initialization or communication with a microcontroller. The chip has the capability to energy harvesting from reader field up to 3mA.

Configuration and logging data is stored on a configurable 9-kbit EEPROM.

Ordering Information and Content Guide appear at end of datasheet.

Key Benefits & Features

The benefits and features of this device are listed below:

Figure 1: **Added Value of Using AS39513**

Benefits	Features
Versatile data logging with selectable option	Programmable logging modes
Logging storage capacity up to 1020 events (8-bit logging mode) with time stamp	On-chip 9-kbit EEPROMReal-time clock (RTC)
Supports data logging from various sensors	On-chip temperature sensorAnalog input for external resistive sensor
On-chip temperature sensor	 Default range: -20°C to 55°C (±0.5°C over -20°C to 10°C, gold bumped die) Temperature range is programmable
Flexible supply options (1)	 Fully passive mode: no battery Semi-passive (BAP) mode: 1.5V or 3V battery
Provides supply for external circuitry	Energy harvesting from reader field up to 3mA



Benefits	Features
 Autonomous data logging with long battery life of ~1 year (with 30mAh printed battery) 	• Standby current (RTC enabled): 2.14μA _{TYP} (@ 3.0V)
Works with NFC-enabled phones and HF readers	 ISO 15693/NFC-V (T5T) compliant Cool-Log™ commands for logging functions
Precludes manipulation and unauthorized usage of data	EEPROM access from reader perpetual protected by password
Flexible range of packages for inlay and PCB surface mount assembly	• Gold bumped die 2403μm x 2313μm

Note(s):

1. After battery is exhausted, the chip will continue working in passive mode (no RTC).

Applications

The AS39513 applications include:

- Cold Chain: Monitoring and tracking of temperature-sensitive products
- Temperature monitoring of medical products
- Pharmaceutical logistics
- Monitoring of fragile goods transportation

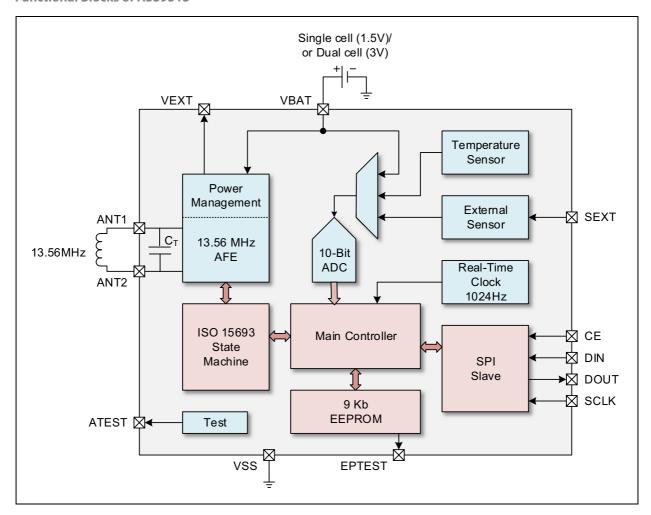
Page 2ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Block Diagram

The functional blocks of this device are shown below:

Figure 2: Functional Blocks of AS39513



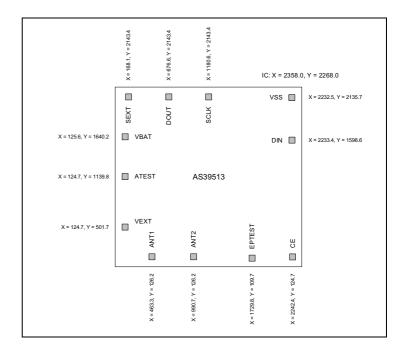
ams Datasheet Page 3
[v1-10] 2018-Apr-25
Document Feedback



Pin and Pad Layout

The AS39513 can be shipped as bare die with gold bumps. When packaged as a bare die, the pad arrangement is as depicted below (measures are reported in μ m).

Figure 3:
Bare Die with Gold Bumps Pinout



Note(s):

1. Bondpad spacing is $\geq 400 \mu m$

Pin Description

Figure 4: Pin Description of AS39513 with Gold Bumps

Pin Name	Pin Type	Description
SCLK	I	SPI CLK input
DOUT	0	Digital data output.
SEXT	I	Analog input for external sensor.
VBAT	S	Battery input.
DIN	I	Digital data input.
VSS	S	Negative supply and ground.
ATEST	0	Analog test output.
VEXT	0	Power output for external circuit, generated by RF field.
CE	I	SPI enable input. Note this is active high.

Page 4ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Pin Name	Pin Type	Description
EPTEST	0	Test pin for EEPROM. Do not connect.
ANT2	I	RF input from antenna.
ANT1	I	RF input from antenna.

The abbreviations used in Figure 4 are given below:

S = Supply

O = Output

I = Input

ams Datasheet Page 5
[v1-10] 2018-Apr-25
Document Feedback



Absolute Maximum Ratings

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under Operating Conditions is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 5:
Absolute Maximum Ratings of AS39513

Symbol	Parameter	Min	Max	Unit	Comments				
		Electrica	al Param	eters					
V _{BAT} /V _{GND}	Supply Voltage to Ground	-0.3	3.7	V					
V _{IN}	Input Pin Voltage to Ground except ANT1, ANT2 and SEXT	-0.3	3.3	V					
	Input Pin Voltage to Ground at ANT1 and ANT2	-0.5	6.5	V					
V _{INSEXT}	Input Pin SEXT Voltage to Ground	-0.3	1.8	V					
I _{IN}	Peak Current Induced on Pin ANT1 and ANT2		30	mA					
I _{SCR}	Input Current (latch-up immunity)	± 100		mA	JEDEC JESD78D Nov 2011 Class 1				
	E	lectrost	atic Disc	harge					
ESD _{HBM}	Electrostatic Discharge HBM	±	: 2	kV	JEDEC JS-001-2014				
ESD _{CDM}	ESD - Charged Device Models	± 5	500	V	JEDEC JESD22-C101F				
	Temperatur	e Range	s and St	orage Co	nditions				
T _{JUNC}	Operating Junction Temperature	-20	65	°C					
T _{STRG}	Storage Temperature Range	-55	150	°C					
T _{BODY}	Package Body Temperature		260	°C	IPC/JEDEC J-STD-020 (1)				
RH _{NC}	Relative Humidity (non-condensing)	5	85	%					
t _{STRG_DOF}	Storage Time for DOF/Die or Wafers on Foil		3	months	Refers to indicated date of packing				
T _{STRG_DOF}	Storage Temperature for DOF/Die or Wafers on Foil	17	28	°C					

Page 6ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Symbol	Parameter	Min	Max	Unit	Comments
RH _{OPEN} _	Relative Humidity for DOF/Die or Wafers on Foil in Open Package		15	%	Opened package
RH _{UNOPEN} _DOF	Relative Humidity for DOF/Die or Wafers on Foil in Sealed Package	40	60	%	Sealed bag

Note(s):

ams Datasheet Page 7
[v1-10] 2018-Apr-25 Document Feedback

^{1.} The reflow peak soldering temperature (body temperature) is specified according IPC/JEDEC J-STD-020 "Moisture/Reflow Sensitivity Classification for Non-hermetic Solid State Surface Mount Devices".



Electrical Characteristics

All limits are guaranteed. The parameters with min and max values are guaranteed with production tests or SQC (Statistical Quality Control) methods.

Figure 6: Electrical Characteristics of AS39513

Symbol	Parameter	Min	Тур	Max	Unit	Conditions
V _{BAT3V}	3V Battery Supply Voltage	2.2		3.3	٧	See note (3)
V _{BAT1.5V}	1.5V Battery Supply Voltage	1.35		1.8	V	See note (3)
V _{BAT_SU}	Minimum Start-Up Input Voltage		0.7		V	T= 6°C Battery assisted mode
V _{ANT}	Power On Voltage	2.5			V _P	
I _{BAT-SD}	Shutdown Current into V _{BAT}		0.5		μΑ	V _{BAT} = 3.6V; 25°C
I _{EXT}	Maximum Current from V _{EXT} Output		3		mA	In electromagnetic field
V _{EXT}	V _{EXT} Limiter Voltage		3.85		V	In electromagnetic field
R _{VEXT}	V _{EXT} Output Resistance		750		Ω	V _{EXT} internally connected to rectifier output for supply of external circuits
C _{TG}	On Chip Capacitance		35		рF	Between ANT1 and ANT2 for die with gold bump
f _{SCLK}	SCLK Serial Data Clock			100	kHz	
f _C	Carrier Frequency		13.56		MHz	
f _{RTC}	RTC Clock		1.024		kHz	
f _{SYS}	System Clock		1.92		MHz	
E _{WCYC}	EEPROM Erase/Write Cycles	10000			Cycles	
t _{DR}	EEPROM Data Retention Time	10			Years	T _{JUNC} = 25°C
t _{E/W}	EEPROM Erase/Write Speed (four-byte block)	6		10	ms	
T _{ACCGB}	Temperature Sensor Accuracy, Gold Bumped Die (logging mode only) ⁽⁴⁾	-0.5		0.5	°C	-20°C to 10°C
t _{LOGINT}	Logging Interval		1 32768		S	LOGINT[15:0] 0001h LOGINT[15:0] 8000h

Page 8ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Symbol	Parameter	Min	Тур	Max	Unit	Conditions
t _{IDLE}	Time to enter idle state after power up		300		μs	
H _{min3Vbat}	Sensitivity 3V battery assisted mode		150		mA/m	Class ID-1 antenna VBAT=3.0V
H _{min1_5Vbat}	Sensitivity 1.5V battery assisted mode		150		mA/m	Class ID-1 antenna VBAT=1.5V
H _{minpass}	Sensitivity passive mode		280		mA/m	Class ID-1 antenna
CMOS	5 Digital Input with 100k Ohm	Pull-Dow	n: CE, SC	LK and DIN	with Pul	ll-Down Enabled ⁽²⁾
V _{IH}	High Level Input Voltage	0.7* V _{BAT}			V	
V _{IL}	Low Level Input Voltage			0.3*V _{BAT}	V	
I _{LEAK}	Input Leakage Current			1	μΑ	V _{IL} = 0V
R _D	Pull-Down Resistance		100		kΩ	
I _{PD}	Pull-Down Current	10		50	μΑ	$V_{IH} = V_{BAT}$
	CMOS Digital Input with 30	k Ohm Pu	ıll-Up Act	ive: DIN wi	th Pull-U	p Enabled
V _{IH}	High Level Input Voltage	0.7* V _{BAT}			V	
V _{IL}	Low Level Input Voltage			0.3*V _{BAT}	V	
I _{LEAK}	Input Leakage Current	-1		1	μΑ	$V_{IH} = V_{BAT}$
R _U	Pull-Up Resistance on DIN (optional see DIMD[1:0])		30		kΩ	
I _{PU}	Pull-Up Current	30		160	μΑ	V _{IL} = 0V
	СМ	OS Digita	l Output	DOUT		
R _{OSO}	Output Resistance Source		1.85		kΩ	
R _{OSI}	Output Resistance Sink		200		Ω	

Note(s):

- 1. Temperature 25°C, supply V_{BAT} =3.3V from RF field unless noted otherwise
- 2. CMOS inputs CE and SCLK have 100k Ohm pull down resistor permanently connected. CMOS Input DIN can be configured with pull up or pull down. See DIMD[1:0].
- 3. Below VBAT=1.35V operation and performance of AS39513 is not guaranteed.
- 4. Temperature sensor accuracy measured performance on wafer with gold bumped die measured at 3.0V for 3V trimmed devices and 1.5V for 1.5V trimmed devices. Assembly method can influence the temperature sensor accuracy.

ams Datasheet Page 9
[v1-10] 2018-Apr-25 Document Feedback



Figure 7: **Current Consumption in Different Modes**

		V _{BAT}	Temperature				
Symbol	Parameter	[V]		[°C]		Unit	Conditions
			-20	25	65		
Len	Idle Mode Current	3.0	0.83	0.81	1.14	μΑ	
l idle	(RTC off)	1.5	0.34	0.37	0.71	μΑ	
14	Wait Mode Current	3.0	2.06	2.06	2.37	μΑ	
l wait	(RTC on)	1.5	1.46	1.52	1.86	μΑ	
1	Active Mode Current	3.0	2.06	2.06	2.37	μΑ	
¹ active	(RTC on)	1.5	1.46	1.52	1.86	μΑ	

Note(s):

1. The values at -20 $^{\circ}\text{C}$ and 65 $^{\circ}\text{C}$ are typical but not measured in final test.

Figure 8:

Operating Conditions

Symbol	Parameter	Min	Max	Unit	Comments
V_{BAT}	Battery Voltage	1.35	3.6	V	
I _{LIM}	Limiter Current		30	mA	
t _{RAMP}	VBAT Ramp up time to 1.35V during power up	30		μs	Ensures correct loading of registers from EEPROM
V _{SEXT}	SEXT Input Voltage	0	1	V	

Page 10 $ams\, Datasheet$ **Document Feedback** [v1-10] 2018-Apr-25



Detailed Description

The AS39513 is designed for use in smart semi-passive labels as well as in full passive labels. Smart semi-passive labels are defined as thin and flexible labels that contain an integrated circuit and a power source. Semi-passive smart labels, also known as battery-assisted back-scattered passive labels, enable enhanced functionality and performance over passive labels. The IC includes sensor functionality and logging of sensor data.

The RFID portion of the AS39513 operates at 13.56 MHz and is fully ISO15693 and NFC-V (T5T) compliant. The sensor controller runs with an independent clock of frequency f_{SYS} . The chip is supplied from a single-cell battery of typically 1.5V, or from a dual cell battery of typically 3V. The on-chip temperature sensor and real-time clock (RTC) accommodate temperature data logging with time stamps.

Power Management

The AS39513 is supplied from either the battery or through the power coupled from the RFID reader. The device (sensors, ADC, real-time clock and logic) is normally supplied from the battery unless there is no battery attached (passive label), or when the battery is drained. When no battery power is available, these circuits will be powered by the RFID reader. The RFID AFE is always powered by the reader.

Note 1.5V and 3V batteries are supported but the battery supply voltage range is not continuous. Please see electrical characteristics. Also it is assumed the battery will be connected when the RF field is not present. Correct operation is not guaranteed if the battery is connected in the presence of an RF field. A minimum ramp up time for VBAT of t_{RAMP} is required to ensure all system registers are correctly loaded from system EEPROM during initialization. This is valid for both 1.5V and 3V battery operation.

Energy Harvesting

AS39513 has harvesting capability. The regulated voltage output pin for energy harvesting is VEXT. If an RFID reader is present, the harvested reader power is then available externally through the VEXT pin. An internal regulator limits the voltage to V_{EXT} . The output impedance R_{VEXT} of this voltage source is fixed.

Analog Front End (AFE)

The analog front end (AFE) operates at a carrier frequency of 13.56 MHz according to the ISO 15693 and NFC-V type 5 tag standards. The incoming data is demodulated from the received ASK (Amplitude Shift Keying) signal, with either 10-30% modulation index or 100% modulation index. Outgoing data is transmitted from the AS39513 using load modulation and employs Manchester coding with one or two sub-carrier frequencies: 423.75 kHz (fc/32) or 484.28 kHz (fc/28).

ams Datasheet Page 11
[v1-10] 2018-Apr-25 Document Feedback



Processing and Digital Control

The AS39513 is fully ISO15693 compliant. The processing of the incoming data is executed by the ISO15693 CODEC block that formats the data in a frame according to the ISO specification.

Both data coding modes (1 out of 256 and 1 out of 4) are supported by the AS39513. The reader (interrogator) makes the mode selection as part of the SOF (Start of Frame). The 1-of-256 data coding mode has a data rate of 1.65 kbit/s (fc/8192) meaning that the transmission of one byte takes 4.833 ms. The 1-of-4 coding has a rate of 26.48 kbit/s (fc/512) with the transmission of one byte requiring 302.08 μ s.

This RFID interface can be used to access most of the EEPROM storage and to control the operating mode of the AS39513.

Slave Serial Interface (SPI-like)

The integrated serial interface (SPI-like) can be used to configure and test the chip.

The SPI-like bus can also be used for the communication between a microcontroller externally attached to the AS39513.

With the correct access password, it can also be used to access all regions of the EEPROM and the AS39513 test modes.

Please note SPI enable is active high. The SPI Read command also has 2 timing issues which need to be observed and are explained in the section SPI timing.

Real-Time Clock (RTC)

The on-chip real-time clock (RTC) is an integrating RC-type oscillator that is factory trimmed to f_{RTC} . This oscillator is used to generate logging intervals t_{LOGINT} and track the time since the chip was first initialized. The start time for the logging process can be programmed in UPC format by writing the related parameter in the EEPROM configuration.

Page 12

Document Feedback

[v1-10] 2018-Apr-25



Temperature Sensor

The on-chip temperature sensor is configured and calibrated to measure temperatures between -20°C to 55°C. The gold bumped die achieve an accuracy T_{ACCGB}. The on-chip sensor can be reconfigured for a number of different temperature ranges but the sensor requires recalibration after each temperature range change.

The temperature sensor is intended to be used in logging mode. The temperature sensor accuracy is only guaranteed in this mode and not in the presence of a strong RF field from a reader. When placed in the presence of a reader, strong RF fields can cause self heating of the chip depending on the field strength, antenna and length of time in the field. The accuracy of the on-chip temperature sensor can then not be guaranteed.

External Sensor

The on-chip external sensor interface provides a means for using both resistive and voltage-based sensors. The voltage at the sensor node can be scaled and shifted in order to cover a voltage range of V_{SEXT}, or a subset of that range.

The external sensor input S_{EXT} can be also used for event-triggered logging. In this condition the logging is not triggered in predefined time intervals from the internal timer, but can be triggered externally, either with a sensor, switch or a microcontroller.

The S_{EXT} has in fact a very low power sensing interface that can be used to trigger logging events when the sensor voltage crosses one of four selectable thresholds. In addition an optional drive current can be supplied to the sensor. The maximum allowable voltage on the SEXT pin is V_{INSEXT}.

Analog to Digital Converter

The chip has an integrated 10-bit analog to digital converter (ADC) with selectable voltage references. It is used for voltage conversion from the temperature sensor, the external sensor, and the external battery voltage.

ams Datasheet Page 13
[v1-10] 2018-Apr-25 Document Feedback



Data Protection

The 9-kbit EEPROM is accessed through a controller that manages the overall chip operation. Every address in the memory map is assigned to one of four types of access levels. There is write protection for three memory areas (System, Application, and Measurement) using three different 32-bit passwords. All three memory areas are open for read at all times. A fourth memory area, called the Factory area, is much more restricted and is not accessible via RF except for the lock bits and passwords. This is used for passwords, memory lock bits, and some calibration information.

For the Application, Measurement and System Access areas the access via RF remains open until the RF field is removed (the access via RF will close with the loss of RF field even if the logic is continuously powered by an external battery). Note if the chip is powered by a battery these areas will still be accessible by SPI.

The chip also supports a one-time use secure mode. When this mode is used, the RFID write capability for all Application and Measurement blocks is blocked. The measurement area can still be written through the logging operations, but the logging results cannot be overwritten through the RFID interface even if the 32-bit password is known.

Page 14

Document Feedback

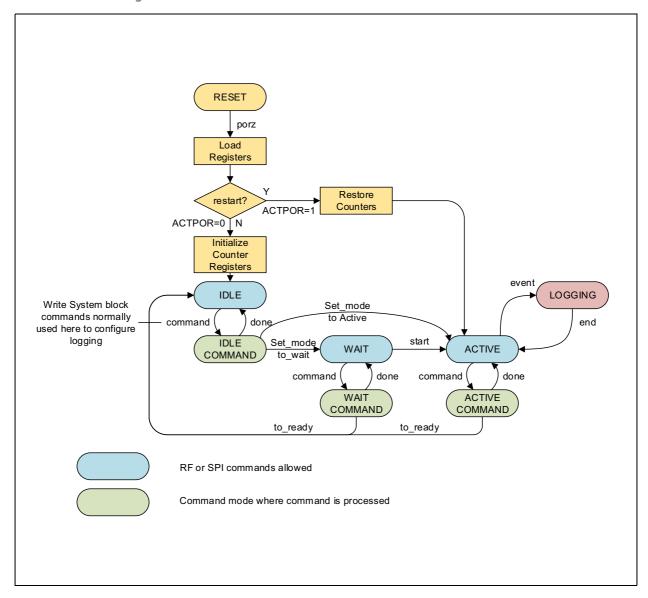
[v1-10] 2018-Apr-25



System Description & Modes of Operation

Once the AS39513 has been powered either from a battery or the RFID interface, the controller logic manages the operation of the IC according to the state diagram below.

Figure 9: State Transition Diagram



The description of each operation mode is reported in the next sections.

ams Datasheet Page 15
[v1-10] 2018-Apr-25 Document Feedback



Initializing the Chip

A virgin chip (not initialized) can be initialized either through the SPI port or through RFID interface from a reader. Once the battery voltage is applied to the VBAT pin or the supply voltage is extracted from the RF field, the AS39513 boots up with the default factory configuration. For battery powered devices it is important that VBAT ramps up with t_{RAMP} minimum to ensure system EEPROM values are correctly loaded into the system registers. This is valid for both 1.5V and 3V battery operation. Within t_{IDIF} after power is applied, the logging controller goes to the IDLE state where it waits for configuration. Once all of the configuration information has been written to the device using write system block commands, the RFID "Set Mode" command is used to place the AS39513 either into the WAIT state or into the ACTIVE state directly. If in the WAIT state, a timer or input action can move the device into the ACTIVE state. Once in the ACTIVE state, the AS39513 will begin logging data whenever a logging event occurs.

RESET Mode

Once the chip powers up, either from the battery or the RF field, and the power is stable, the initialization process begins. At this point, the controller logic will read specific EEPROM addresses and load them into "shadow" registers.

During this phase the battery type will be determined by checking System parameter BTYPE available in the EEPROM field.

Two of the other EEPROM fields that will be read during this phase are the System parameters WAKEMD (wakeup mode) and ACTIVE (true if last state was ACTIVE). If both of these fields are high, it means that the chip was reinitialized from a previous ACTIVE mode and the restart condition flag ACTPOR will be set to high.

If the restart condition is true (ACTPOR is high) then the measurement pointers and counters are reloaded from the last available state and the device returns to the ACTIVE mode.

If the restart condition is false (ACTPOR is low), the register pointers and counters are initialized assuming that no measurements have been made but the MEASCNT and MEASPTR values in EEPROM will be retained, and the device enters IDLE mode. This means that if for example the battery voltage dropped during a logging event and caused a POR, the chip would enter idle mode ie stop, but the MEASCNT and MEASPTR values would be retained in EEPROM. If the mode is subsequently changed to Active (i.e. logging is restarted), the EEPROM MEASCNT and MEASPTR are zeroed. (The bit fields ACTPOR, WAKEMD, and ACTIVE are further documented in the Memory Map section).

Page 16

Document Feedback

[v1-10] 2018-Apr-25



IDLE Mode

In the IDLE mode the device is waiting for commands either from the RFID or SPI interface. In this state the device can be first initialized after the first power up by setting the related EEPROM parameters. Initiating either interface and sending a command enables the internal "command" signal that moves the device into IDLE COMMAND mode.

In IDLE mode the data logging parameters can be configured using Write System Block commands. Once fully configured a Set mode command can be used to either commence logging or change state to the WAIT state.

WAIT Mode

In WAIT mode the device is waiting before to enter in the ACTIVE mode for a defined condition that is dependent on the System parameters (Logging Control Parameters) set in the EEPROM. WAIT mode provides in fact a mechanism to delay the start of logging after the Set Mode command is issued.

If the parameter TMSRT is set to 1, then the WAIT mode will transition to the ACTIVE mode after LOGDEL*512 seconds, where LOGDEL is also part of the System Parameters.

If the parameter DIMD[1:0] is 2'b10, then the WAIT mode will transition to the ACTIVE mode when the DIN pin is pulled low.

If TMSRT is 0 and DIMD is not 2'b10, then the WAIT mode will transition without delay to the ACTIVE mode. (The bit fields TMSRT, DIMD, and LOGDEL are further documented in the Memory Map section.)

Commands from either the RFID or SPI interfaces are accepted in the WAIT mode. If a command request and a start event occur at the exact same time, the command processing has priority; the mode will transition to ACTIVE when the command is done. If a command is being processed when a start event occurs, the start event is pending until the command is completed and then the transition to ACTIVE mode occurs.

When the device transitions from the WAIT to the ACTIVE mode, the real time clock counter (RTC) is reset to 0. In this way, the baseline time of the AS39513 is the time that the device was placed in ACTIVE mode.

ams Datasheet Page 17
[v1-10] 2018-Apr-25 Document Feedback



ACTIVE Mode

In ACTIVE mode, the device waits for a logging event to begin logging. The logging events can be generated by the real-time clock, a voltage level on the SEXT pin, or a digital signal on the DIN pin. Each type of logging event can be individually enabled by System parameters in the EEPROM. When any one of the enabled logging events occur, the mode transitions to the LOGGING mode and the data measurement and logging commences. If two logging events happen to occur in the exact same clock cycle, only one logging operation will be performed.

Commands from either the RFID or SPI interfaces are accepted in the ACTIVE mode. If a command request and a logging event occur at the exact same time, the command request has priority. If a command is being processed when a logging event occurs, the logging event is pending until the command is completed and then the logging commences.

COMMAND Mode

The COMMAND modes process a command either from the RFID or SPI interface. Whichever interface issues the command first gets priority. The other interface will get a "device busy" error until the first command is completed. If both interfaces happen to request a command on the exact same clock edge (very unlikely), the RFID interface will get priority.

There are three versions of COMMAND mode, one for each of the calling modes: IDLE, WAIT, and ACTIVE. The only difference in these COMMAND modes is that when the command processing is complete, the mode will return to the mode that initiated the command.

The exception is the command that purposely generates a mode change, Set Mode. For example, if the device is in the IDLE mode and the Set Mode command is called to change to the WAIT mode, the device returns from the IDLE COMMAND mode to the WAIT mode.

LOGGING Mode

In LOGGING mode, a sequence of measurements followed by an optional sequence of storing logging values takes place. This sequence is described in the following subsections.

Page 18
Document Feedback
[v1-10] 2018-Apr-25



Battery Check

Before executing any measurement it is possible to check the status of the battery by performing the so called Battery Check. It is executed if the System parameter BATCHK is set to 1, then a coarse battery check is enabled. The reason of performing this check is that the power-on-reset only ensures that the battery voltage is enough for the logic to function but it does not guarantee that the battery voltage is within the tolerances for accurate measurements.

The battery check involves the following steps. First, the battery check sensor elements are enabled. There is a brief wait for the analog circuits to settle. Using the battery type determined during RESET mode, the battery check comparator output will indicate if the battery voltage is acceptable. If it is, then the rest of the logging continues, if it is not, the logging stops, and the error flag, present in the System parameter, LOWBAT is set. Note that if a logging event was skipped because of low battery, the measurement counter is still incremented to give some indication of how many measurements were skipped. Because the battery may be too weak for a reliable write, the measurement counter will not be written to EEPROM if the battery voltage check has failed.

Figure 10: Battery Check Threshold Voltages

Battery Type	BCKSEL [1:0]	Threshold Voltage (V)
1.5V	00	1.2
3V	00	2.2
3V	01	2.1
3V	10	2.0
3V	11	1.9

ams Datasheet Page 19
[v1-10] 2018-Apr-25 Document Feedback



Sensor Measurements

After the battery check, the sensor measurements are made. The three possible measurement that consist of Temperature, External Sensor and Battery Voltage are independently enabled by the System parameters TSMEAS, EXMEAS, and BVMEAS part of the System EEPROM fields, and they are executed in a fixed sequence as they are reported below.

First, there is the temperature measurement. If TSMEAS is 1, the temperature circuits are enabled, and the temperature configuration values for the references and ADC are loaded. After a wait period for analog settling, an ADC measurement is taken, and the result is stored in ts_res_ff[9:0].

Next is the external sensor measurement. If EXMEAS is 1, the external sensor circuitry is enabled, including the optional current drive for the external sensor. The external sensor values for the references and ADC are loaded, and a wait period ensues to allow for analog settling. After the wait period, an ADC measurement is taken, and the result is stored in ex_ref_ff[9:0].

Finally, there is the battery voltage measurement. If BVMEAS is 1, the battery measurement circuits are enabled, and the battery voltage configuration values for the reference and ADC are loaded. After a wait period for analog settling, an ADC measurement is taken, and the result is stored in bv_res_ff[9:0].

Page 20
Document Feedback
[v1-10] 2018-Apr-25



Limit Check Algorithm

Once all the enabled measurements are done, an optional limit check algorithm begins. The AS39513 can be set to only record logging information if certain limit conditions are met. The internal temperature sensor and external sensor each have independent limit conditions. The ADC result for each sensor measurement is compared to four thresholds to determine the limit result. The limit thresholds are each 8-bit in length and are the 8 MSB values when compared to the 10-bit ADC values. The limit results follow the tables below. If a sensor is not enabled for logging, its limit result is taken to be 3'b000.

Figure 11: Limit Check Results for Temperature Sensor

Step	Condition	ts_lim
1	ts_res_ff ≥ { TXHILIM, 2′b00 }	3′b100
2	ts_res_ff ≤ { TXLOLIM, 2'b11 }	3'b101
3	ts_res_ff ≥ { THILIM, 2′b00 }	3'b110
4	ts_res_ff ≤ { TLOLIM, 2′b11 }	3′b111
5	Otherwise	3'b000

Figure 12: Limit Check Results for External Sensor

Step	Condition	ex_lim
1	ex_res_ff ≥ { EXHILIM, 2'b00 }	3'b100
2	ex_res_ff ≤ { EXLOLIM, 2′b11 }	3'b101
3	ex_res_ff ≥ { EHILIM, 2′b00 }	3'b110
4	ex_res_ff ≤ { ELOLIM, 2'b11 }	3'b111
5	Otherwise	3'b000

Note that in the computation of the limit result, the conditions are checked in the order given in the tables above. It is possible that more than one condition can be met at the same time, because there is no check on the relative values of the four limit parameters for each sensor. The first condition that is true in the order given in the table is the condition that determines the limit result.

ams Datasheet Page 21
[v1-10] 2018-Apr-25 Document Feedback



The limit check algorithm is as follows. The limit result for each sensor is computed. For each limit result that is non-zero, the limit counter that corresponds to that limit flag is incremented. The over limit count flag OVLIM will be set if any of the following conditions are true: TXHICNT > 0, TXLOCNT > 0, THICNT > THIMAX, TLOCNT > TLOMAX, EXHICNT > 0, EXLOCNT > 0, EHICNT > EHIMAX, or ELOCNT > ELOMAX (These System parameters are further documented in the Memory Map section).

There are two types of limit check modes: normal and limit crossing.

If normal limit mode is selected (LOGMD = 2'b10), then logging will occur if, and only if, at least one of the two sensor's limit results is non-zero.

If limit crossing mode is selected (LOGMD = 2'b11), then logging will occur if, and only if, the limit result for either sensor is different from that sensor's previous measurement limit result. At initialization, the "previous" limit result for each sensor is assumed to be 3'b000. Therefore, the first measurement that will be logged will be the first time that at least one of the two sensor's limit results is non-zero.

If neither of the limit modes are selected (LOGMD[1] = 0), then no limits are checked, the limit counters are not changed, and the measurement results are always logged.

Measurement Results Logging

If one of the limit criteria are satisfied, or if the device is in the no-limit logging mode (LOGMD = 2'b00 or 2'b01), than the measurement results are logged.

Memory Check: Prior to writing the log values in EEPROM, the logging measurement pointer MEASPTR[11:0] is checked to insure that there will be room for the log data.

If there is no room and STRMD is 0, the data is not logged, and the error flag EEFULL is set.

Page 22

Document Feedback

[v1-10] 2018-Apr-25

^{1.} The limit counters are simple binary counters. If a limit count exceeds 16'hFFFF (65535), then the count will wrap around to zero.



Memory Pointer: Assuming the data can and should be logged, the logging begins at the current value of the MEASPTR[11:0], where MEASPTR[11:2] represents the EEPROM address for the first log data, and 2*MEASPTR[1:0] is the bit position at which to start the log data. The data is logged in the following order, with increasing pointer addresses for each log value.

Once all the logging values are stored, and if the adjust logging information ADJUST parameter is set to 1, then the MEASPTR is rounded up to the nearest byte boundary. This wastes some memory space in return for being able to easily calculate the byte position of each log point.

Format Options: In order to minimize EEPROM usage, data is logged at 2-bit boundaries according to the format options LOGFMT: all measurement data is logged using either 8 or 10 bits

The 8-bit format is used if both logging mode LOGMD = 2′b00 and logging format LOGFMT = 0. Otherwise, 10 bits are used.

Measurement Storing Sequence: First, if a temperature measurement was made, the result in ts_res_ff is written. Second, if an external measurement was made, the value in ex_ref_ff is written. Third, if a battery voltage measurement was made, the result in bv_res_ff is written.

Note the number of bits (8 or 10) stored for the temperature, external sensor and battery voltage measurements depends on the LOGFMT and LOGMD configuration settings.

Optional Status Signals: After the measurements are recorded, the status of two digital signals can optionally be recorded. If the optional logging data DLOG is 1, then the values of the digital signals at the DIN pin (the digital input din_i) and the external sensor interrupt SEXT (extirq_i) are recorded using the 2-bit value { din_i, extirq_i }.

Note that if DLOG is the only logging option selected, that means, there are no ADC measurements enabled, then the logging state machine will wait about 3ms (the approximate time for one ADC conversion) in order for the external voltage at the SEXT pin to settle.

Note that if the value of the extirq_i signal want to be used, then the Enable external sensor interrupt EIEN field must be set to 1 in order to enable the comparator that generates the extirq_i interrupt event.

Logging Modes: Finally, information about this measurement are written, depending on the logging mode.

If interrupt logging mode is used (LOGMD = 2'b01), then the 30-bit real-time clock counter value is logged, followed by a two-bit value that indicates the logging event trigger source (further detail will follow in the Memory Map section).

If one of the two limit logging modes is used (LOGMD = 2'b01 or LOGMD = 2'b11), the 16-bit log counter LOGCNT is written into the EEPROM.

ams Datasheet Page 23
[v1-10] 2018-Apr-25 Document Feedback



Status Parameters: As a last step in the logging operation, the measurement count, MEASCNT, is incremented.

If update counts SKIP16 = 0 or MEASCNT[3:0] = 4'b1111, then MEASCNT, the status bits ACTIVE, EEFULL, OVWRT, ADCERR, LOWBAT, and OVLIM, and the ending measurement pointer MEASPTR are written into EEPROM.

Even if no logging occurred (because the limit conditions were not met or the EEPROM was full), the measurement count MEASCNT is still incremented and written into EEPROM (still using the SKIP16 option to only write once every 16 measurements). The measurement counter MEASCNT clips at 16'hFFFF so that it does not wraparound to 0. The measurement pointer MEASPTR is only updated if data was logged to the EEPROM; it always points to just after the end of the data that was actually written to EEPROM.

Logging Arbitration: In the condition that another enabled logging event occurs before the logging of the current event is complete, the next logging event will be queued and will commence at the completion of the current logging operation.

If an RFID or SPI command request occurs during logging, the command is ignored in order to prevent conflicts in EEPROM access.

Power Modes

The controller modes described above also control which of the sensor blocks are enabled.

If the controller is in any of the COMMAND modes, the LOGGING mode or the RESET initialization, there is a high-speed (f_{SYS}=1.92 MHz) ring oscillator that is enabled to clock the controller logic and the EEPROM.

In the LOGGING mode, there are three additional power modes. Battery check mode (bchk_md) enables all the sensor circuits needed to do the coarse battery check, which is basically everything in the sensor system except the ADC. Measure mode (meas_md) enables basically everything in the sensor system except the battery check circuit; this mode is used for temperature and external sensor measurements. Battery voltage mode (both bchk_md and meas_md enabled) is used to measure the battery voltage.

If the AS39513 is not in one of the modes requiring the ring oscillator, the ring oscillator is disabled and the lowpow signal is asserted. This signal causes the power switch in the AFE to switch to an unregulated supply for the logic, further reducing the power consumption. The only circuits that are operational in this low power mode that would draw current from the external battery are the real time oscillator (if OSCEN = 1) and the external interrupt comparator (if EIEN = 1).

Page 24

Document Feedback

[v1-10] 2018-Apr-25



Data Log Functions

The AS39513 device supports various flexible data log formats. The data log format depends on the Logging form. The data log formats are defined in Figure below. The Logging form is set with the logging mode LOGMD[1:0] System parameter stored in the Logging Control Parameters address 0x43B (bits 4-5) in the EEPROM.

Figure 13: **Supported Logging Formats**

Bit 5	Bit 4	Logging Form	Description	
0	0	Dense	Logging will occur for all logging events. No measurement count or real-time clock values will be logged.	
0	1	Interrupt	Interrupt mode. Logging will occur for all logging events. Sensors are always logged to 10-bit accuracy. The real-time clock value and interrupt source are logged. The interrupt source is a two-bit value: 2'b01 = external sensor interrupt, and 2'b10 = DIN interrupt.	
1	0	Normal limit	Enable logging if any of the limit check conditions are met. Sensors ar always logged to 10-bit accuracy. If a measurement is logged, the valu of the measurement counter is also logged.	
1	1	Limit crossing	Enable logging only if one of the limit check conditions is different than that from the previous logging event. Sensors are always logged to 10-bit accuracy. If a measurement is logged, the value of the measurement counter is also logged.	

Storage Mode

The storage mode defines what happens when the logging area in the EEPROM is full.

The storage mode is set with the storage mode STRMD System parameter, stored in the Logging Control Parameters address 0x40E (bit 6) in the EEPROM.

Figure 14: **Storage Mode**

Bit	Storage Mode	Description
0	Normal	When the logging area in the EEPROM is full, the chip does not store any new sensor data to the EEPROM, additional logging values will be lost.

ams Datasheet Page 25 Document Feedback



Logging Timer

The AS39513 device has an integrated RC oscillator that is calibrated to f_{RTC} . This oscillator drives the logging timer. The logging timer resolution is 1 second. The maximum period is t_{LOGINT} =9.1 hours (32768 seconds). The logging interval is programmed by setting the LOGINT System parameter.

The measurement real time is derived from 4 parameters – the Start time (STIME), the Delay time (LOGDEL), the log interval (LOGINT), and the # of the measurement (MEASCNT). This value has to be calculated in the reader by the equation:

Real time = STIME+LOGDEL+LOGINT*MEASCNT

Delay Time

The AS39513 supports delayed start of the logging procedure. The Delay time has a resolution of 8 minutes - 32 seconds (512 seconds) and a maximum value of 582 hours (12 bits). The delay time value is set with the LOGDEL System parameter, while the Delay time counter starts counting when the device enter in WAIT mode.

The delay time can also be disabled and an external push button at the DIN pin can be used for starting the logging procedure. When in the WAIT state, a pull-up current is supplied to DIN. A falling edge on DIN manually causes a transition from WAIT mode to ACTIVE mode.

Page 26
Document Feedback
[v1-10] 2018-Apr-25



Manual Log Start

In addition to the delayed Start Log, the application can start the logging manually (without a RFID reader). The manual control can be of 2 types:

- 1. To manually execute the transaction from WAIT to ACTIVE mode. When in WAIT mode, a pull-up current is supplied to DIN pin. A falling edge on DIN, for instance generated by an external button, manually cause the transaction.
- To manually execute a logging event when the device is in ACTIVE mode. When in ACTIVE mode, a pull-up current is supplied to DIN pin. A falling edge on DIN, for instance generated by an external button, manually cause the logging event.

During ACTIVE mode, a pull-up current is supplied to DIN, so the only required external component is the button. A falling edge on DIN generates a logging event and the logging will be started.

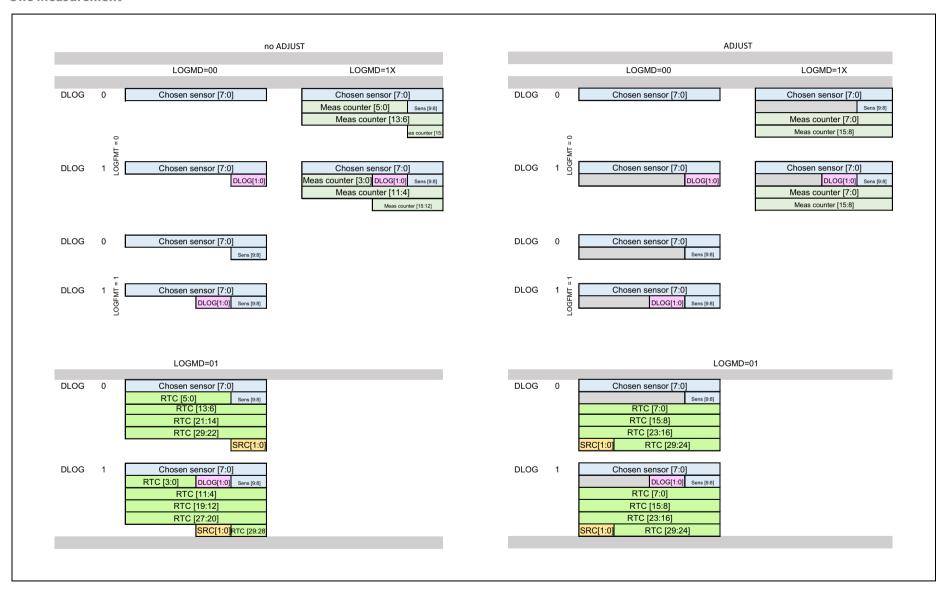
Logging Mode Data Formats

The data formats for the various logging modes are shown in Figures 15 to 19. The start address for the Measured (logged) data is determined by APPBLKS. If APPBLKS = 0 the start address for Measured data is byte address 0x004. Note each new measurement is added in the memory from right to left with the LSB of the next measurement starting at the first free bit from the right immediately next to the previous measurement.

ams Datasheet Page 27
[v1-10] 2018-Apr-25 Document Feedback



Figure 15:
One Measurement



Page 28

Document Feedback

[v1-10] 2018-Apr-25

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Figure 16: One Sensor + Battery

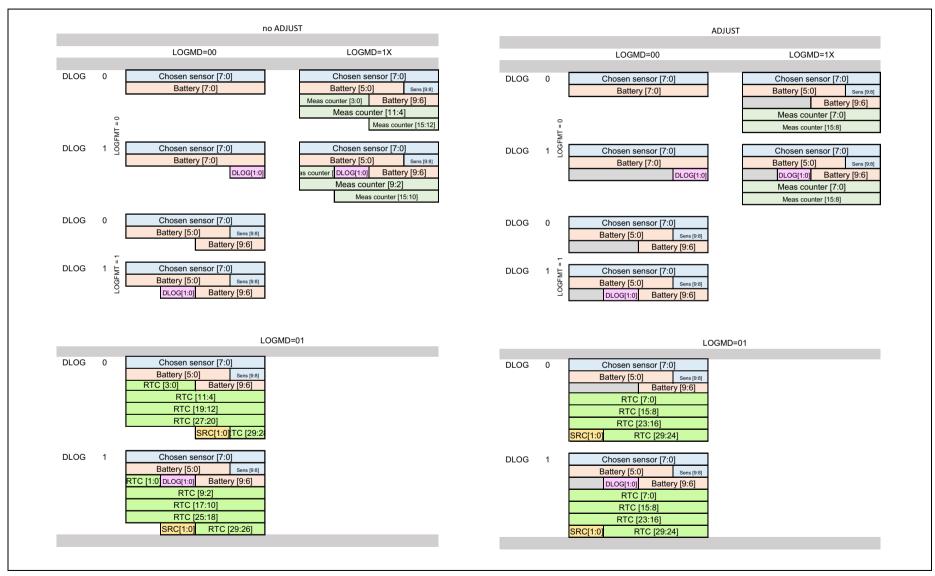
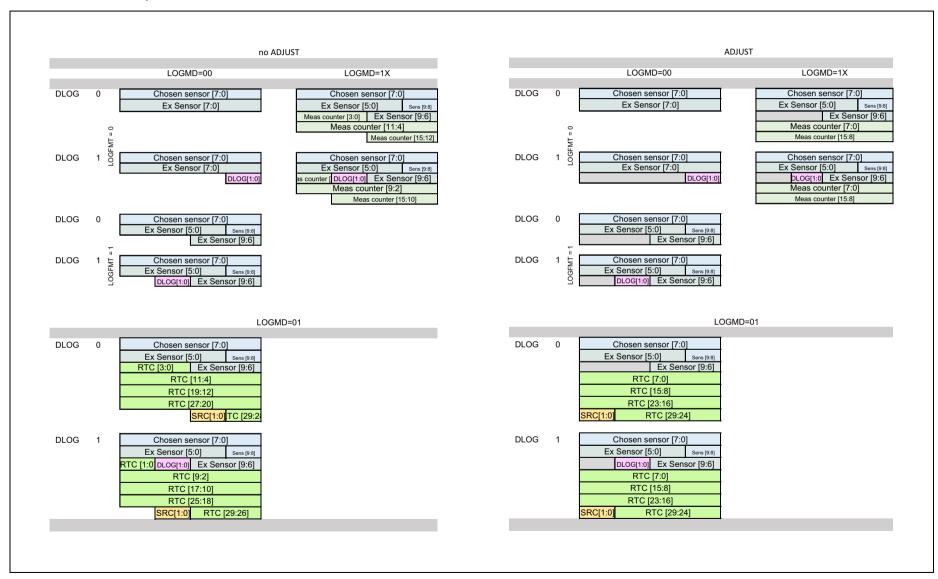




Figure 17: Two Sensors No Battery



Page 30

Document Feedback

[v1-10] 2018-Apr-25

amii

Figure 18: Two Sensors + Battery

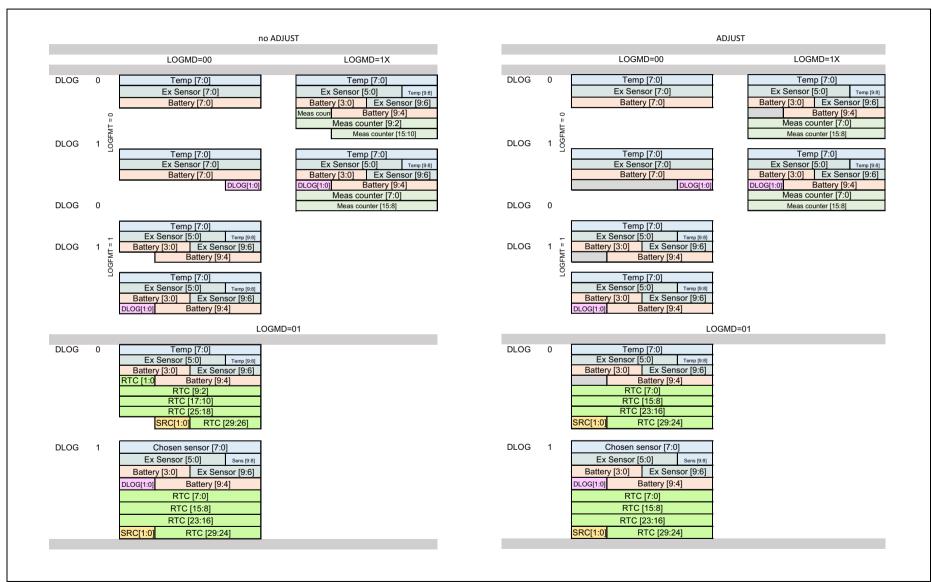
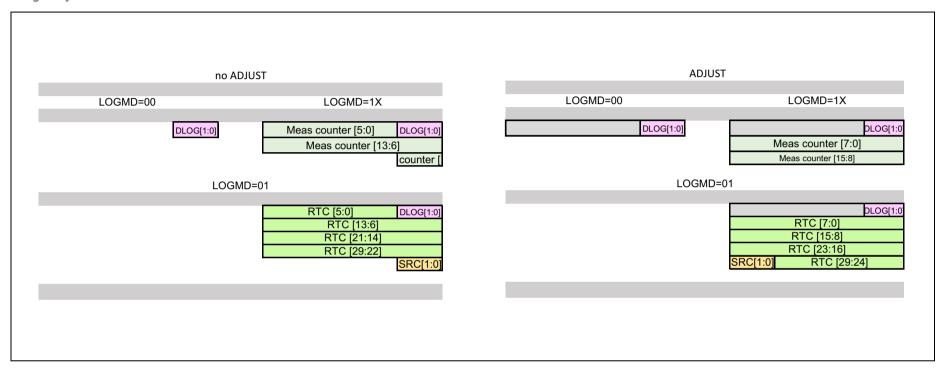




Figure 19: DLog Only



Page 32

Document Feedback

[v1-10] 2018-Apr-25



Analog to Digital Conversion

This section describes how to compute the ADC output code that will result from a sensor input. A block diagram of the sensor interface and ADC is shown in Figure 20.

Figure 20: Sensor Interface and ADC Block Diagram

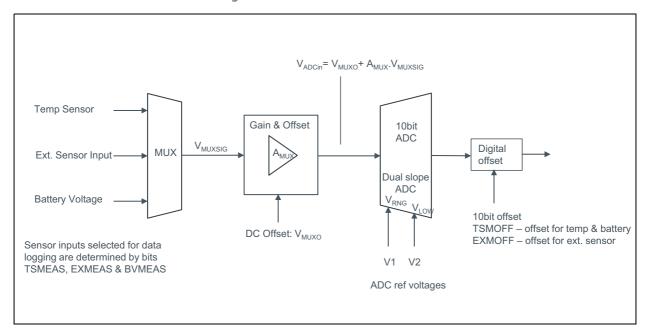
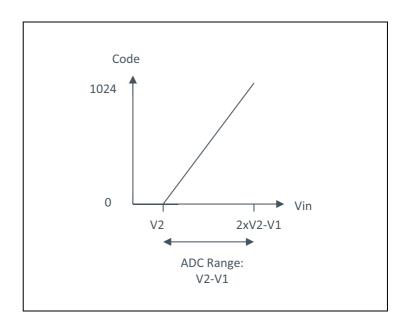


Figure 21: ADC Input-Output Characteristic



ams Datasheet Page 33
[v1-10] 2018-Apr-25 Document Feedback



Reference Voltage Generator

There are two programmable reference voltages used in the AS39513 sensor system, V_1 and V_2 . In a trimmed device, these voltages are

(EQ1)
$$V_1 = V_{STEP}(3.2 + V1SET)$$

(EQ2)
$$V_2 = V_{STEP}(5.2 + V2SET)$$

Where V_{STEP} is 50mV, and V1SET, V2SET values are determined by the measurement type according to the Figure 22 below. The range of possible V1 and V2 ADC reference voltages are shown in Figure 23. If the temperature range is changed from the default by changing TV1SET and/or TV2SET the chip will need recalibrating to produce new trim values. The same is valid for EV1SET, EV2SAT.

ADC input voltage range: $V_2 \le V_{in} \le 2V_2 - V_1$

Note this has the consequence that TV2SET must be set to be \geq TV1SET-1 so that the ADC input signal range V2-V1 is positive. Similarly EV2SET must be set so that EV2SET \geq EV1SET-1.

Figure 22:
ADC Reference Voltage (defaults shown in brackets)

Value	Measurement Type			
	Temperature	External	Battery	
V1SET	TV1SET[2:0] (3'b010)	EV1SET[2:0] (3'b010)	(3'b000)	
V2SET	TV2SET[2:0] (3'b011)	EV2SET[2:0] (3'b101)	(3'b001)	

Figure 23:
ADC Reference Voltages Versus V1SET, V2SET Values

V1SET	V1	V2SET	V2
0	160mV	0	260mV
1	210mV	1	310mV
2	260mV	2	360mV
3	310mV	3	410mV
4	360mV	4	460mV
5	410mV	5	510mV
6	460mV	6	560mV
7	510mV	7	610mV

Page 34

Document Feedback

[v1-10] 2018-Apr-25



ADC Scaling

The selected sensor input (temperature or battery or ext. sensor) is passed through a buffer amplifier and then to the ADC. The buffer amplifier has a selectable gain and offset. The ADC then takes this buffered signal in combination with the selected reference voltages and produces and output code between 0 and 1023.

The first step in computing the ADC code is to determine the source of the gndv1 setting and the mux_gain setting. They depend on the type of measurement according to the table below.

Figure 24: ADC Scaling (defaults shown in brackets)

Value	Measurement Type			
value	Temperature	External	Battery	
gndv1	TSV1G (1'b0)	EXV1G (1'b0)	1	
mux_gain 2'b00		EXGAIN (2'b00)	2'b00	

The parameters gndv1 and mux_gain determine the value of the voltage and gain constants V_{LOW} , V_{RNG} , V_{MUXO} , and A_{MUX} according to the table below.

Figure 25: ADC Voltage and Gain Constants

User Defined		V _{LOW} V _{RNG}	V _{RNG}	V _{MUXO}	A _{MUX}	Comments
mux_gain	gndv1	LOW	RNG	WUXU	YWUX	Comments
00	0	V ₂	V ₁	0	1	Defaults for temp and ext. sensor input
00	1	V ₂	0	0	1	Defaults for battery
01	0	V ₂	V ₁	2V ₁	-1	
01	1	V ₂	0	2V ₁	-1	
1x	0	V ₂	V ₁	$\frac{4}{3}V_1$	$-\frac{1}{3}$	
1x	1	V ₂	0	$\frac{4}{3}$ V ₁	$-\frac{1}{3}$	

ams Datasheet Page 35
[v1-10] 2018-Apr-25
Document Feedback



These constants in turn are used to calculate the effective ADC offset and scale factor, V_{ZERO} and V_{SCALE} , where

$$\text{(EQ3)} \quad V_{ZERO} = \frac{V_{LOW} - V_{MUXO}}{A_{MUX}}$$

$$\mbox{(EQ4)} \quad \ V_{SCALE} = \frac{V_{LOW} - V_{RNG}}{A_{MUX}} \label{eq:VSCALE}$$

The ADC output code, n_{ADC}, will then be

(EQ5)
$$n_{ADC} = 1024 \frac{V_{SIG} - V_{ZERO}}{V_{SCALE}}$$

(EQ6)
$$V_{SIG} = (n_{ADC} \bullet V_{SCALE})/1024 + V_{ZERO}$$

where V_{SIG} is the voltage of the selected multiplexer signal ($V_{SIG,TEMP}$, $V_{SIG,EXT}$, $V_{SIG,BAT1}$, or $V_{SIG,BAT2}$).

Since the ADC voltage ranges for various settings can overlap, it is often not obvious which are the optimum settings for a given sensor voltage range. An Excel spreadsheet entitled "AS39513 ADC Settings.xslx" has been developed which shows the effect of the ADC references and sensor configuration settings on the temperature and external sensor input ranges.

Page 36ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



ADC Output and Range for Temperature Measurement

The temperature sensor produces a signal voltage that is given by the formula

(EQ7)
$$V_{SIG, TEMP} = \frac{T + 273.15}{601.3}$$

where T is the device temperature in degrees Celsius.

Various temperature ranges are possible for the on-chip temperature sensor with different settings of TV1SET and TV2SET (mux_gain and gndv1 are always 00 and 0 respectively for temperature measurements). The nominal default temperature range with TV1SET=2, TV2SET=3 (implies ADC reference voltages VRNG=V1= 260mV VLOW=V2=410mV) is -26.5°C to 63.5°C. Accuracy of the temperature sensor is T_{ACCGB}. Possible temperature ranges are shown in Figure 26.

ams Datasheet Page 37
[v1-10] 2018-Apr-25 Document Feedback



Figure 26: Temperature Ranges Possible with Different TV1SET and TV2SET Values

TV1SET	TV2SET	Temperature °C					
IVISLI	IVZSLI	Start	End	Range			
0	3	-26.6	123.6	150.2			
1	3	-26.6	93.5	120.1			
2	3	-26.6 ⁽²⁾	63.5	90.1			
3	3	-26.6	33.5	60.1			
4	3	-26.6	3.5	30.1			
2	4	3.5	123.6	120.1			
3	4	3.5	93.6	90.1			
4	4	3.5	63.5	60			
5	4	3.5	33.5	30			
4	5	33.5	123.6	90.1			
5	5	33.5	93.6	60.1			
6	5	33.5	63.6	30.1			
6	6	63.6	123.7	60.1			
7	6	63.6	93.6	30			

Note(s):

Page 38ams DatasheetDocument Feedback[v1-10] 2018-Apr-25

^{1.} Colored row indicated default range.

^{2.} The temperature sensor has a temperature range starting at -26.6°C, but the chip operating temperature range restricts the lower limit to -20°C. The default upper limit of the temperature sensor is guaranteed 55°C minimum and nominally 63.5°C. The upper limit may be lower than the nominal 63.5°C due to calibration, but an upper limit of 55°C is guaranteed.



ADC Output and Range for Battery Measurement

The battery sensor uses a voltage divider that depends on the battery type. If the battery type is set to a single cell battery, the signal voltage is

(EQ8)
$$V_{SIG, BAT1} = \frac{V_{BAT}}{2.84}$$

Where VBAT is the voltage at the VBAT pin.

If the battery type is set to a dual cell battery, the signal voltage is

(EQ9)
$$V_{SIG, BAT2} = \frac{V_{BAT}}{5.51}$$

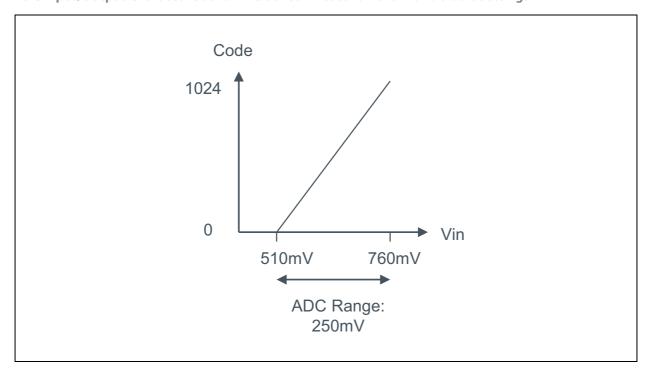
The configuration settings for battery measurement are V1SET= 3'b000, V2SET=3'b001 mux_gain=00 and gndv1=1 which translates to ADC reference voltages of VRNG=0 and VLOW=V2=310mV.

ADC Output and Range for External Sensor Measurement

The external sensor is just a switch to the SEXT pin, so the signal voltage, VSIG, EXT, is just the voltage at the SEXT pin.

The configuration settings for ext. sensor measurement are EV1SET= 3'b010, EVSET2= 3'b101 mux_gain=00 and gndv1=0 which translates to ADC reference voltages of V_{RNG} =V1=260mV and V_{LOW} =V2=510mV. This translates to an SEXT input voltage range 510 – 760mV typ.

Figure 27:
ADC Input/Output Characteristic for Ext. Sensor Measurement with Default Settings



ams Datasheet Page 39
[v1-10] 2018-Apr-25 Document Feedback



GPIO

When the SPI is not used (CE open or low), the DIN and DOUT pins can be used as general purpose IOs (unless the SPI direct command "Set IO Mode" has locked the device in SPI mode).

The functions of the DIN can be programmed as follows according to the System parameter DIMD[1:0] stored in the "Logging Control Parameters" address 0x439 (bits 1-0) in the EEPROM:

Figure 28: DIN Functional Options (GPIO)

Bit 1	Bit 0	I/O	Structure	Function
0	0	Input	Pull-down	CMOS input, non-inverting 100k ohm pull down to ground enabled.
0	1	Input	Pull-up	Pull-up current is supplied to DIN only during a logging event.
1	0	Input	Pull-up	When in the WAIT state, a pull-up current is supplied to DIN. A falling edge on DIN manually causes a transition from WAIT mode to ACTIVE mode. If TMSRT is also 1, the event that happens first (delay or DIN input) causes the transition from WAIT mode to ACTIVE mode.
1	1	Input	Pull-up	During ACTIVE mode, a pull-up current is supplied to DIN. A falling edge on DIN generates a logging event.

Page 40ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



When CE is high, DOUT is used as part of the SPI. When CE is low and the IO mode is set using the Direct SPI command 'Set IO Mode' to Application mode, then the function of DOUT can be configured by DOMD[1:]0] and DOSCR[1:0].

The functions of the DOUT can be programmed as follows according to the System parameter DOMD[1:0] stored in the "Logging Control Parameters" address 0x439 (bits 5- 4) in the EEPROM:

Figure 29: DOMD[1:0]: DOUT Functional Options (GPIO)

Bit 5	Bit 4	I/O	Structure	Function
0	0	Output	CMOS output	CMOS (push-pull) output (this setting is used in SPI mode)
0	1	Output	Pull-up	Pull-up output
1	0	Output	Pull-down output	DOUT is inverted relative to DOSRC description below
1	1	Output	High impedance	High impedance (disconnected) output. Default value.

DOSRC [1:0] stored in the "Logging Control Parameters" address 0x439 (bits 7- 6) in the EEPROM:

Figure 30: DOSRC[1:0]: DOUT Functional Options: Digital Output Source (when not in SPI communication).

Bit 7	Bit 6	Function
0	0	DOUT is a copy of the external interrupt comparator output.
0	1	DOUT is high when an ISO 15693 command has been recognized and is being processed.
1	0	DOUT is high when the RF field is available
1	1	DOUT is the logical OR of EEFULL, ADCERR, LOWBAT, and OVLIM. If OSCEN=1, the output is AND'd with a modulated signal that is 1/32 second high (32 counts of osc1k) and 31/32 second low (992 counts of osc1k).

ams Datasheet Page 41
[v1-10] 2018-Apr-25 Document Feedback



Memory Map

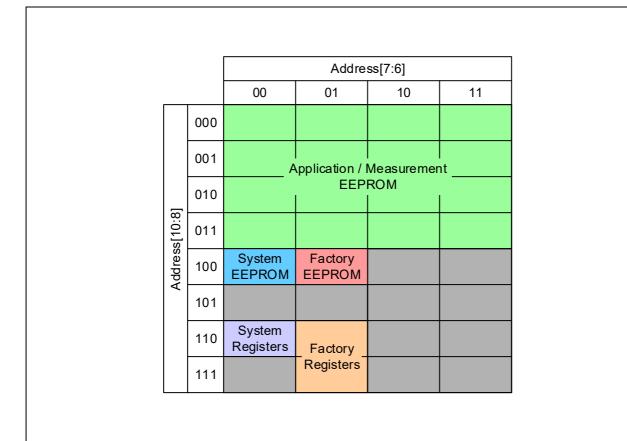
The EEPROM memory as well as registers share a common 11-bit memory space.

From the related 11-bit address it is then possible to access the EEPROM as well as the register and moreover it is possible to know which Access level is required to access each memory area.

By decoding the address MSBs is possible to determine both the type of hardware (EEPROM or registers) and the access level required (Application, Measurement, System, or Factory).

The overall memory layout is described in the figure shown below.

Figure 31: Memory Map Layout



The gray regions in this memory map duplicate other regions to simplify address decoding.

Page 42ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



The decoding of the address MSBs can discriminate the addressed memory area as follows:

EEPROM area with Application or Measurement access level

If the Address[10] is 0 then the addressed memory are is EEPROM and the access level is either Application or Measurement. The boundary between the Application and Measurement regions is determined by the number of four-byte memory blocks, APPBLKS parameter, described later in this section.

• EEPROM area with System or Factory access level

If the Address[10:9] is 2'b10 then the addressed memory is the upper part of the EEPROM.

If the Address[6] is 0, the access level is System, and if Address[6] is 1, the access level is Factory.

The Address[8:7] is simply ignored and treated as if those two bits were 0.

• Registers area with System or Factory access level

If the Address[10:9] is 2'b11, the memory hardware is registers in the logic.

If the Address[6] is 0, the access level is System, and if the Address[6] is 1, the access level is Factory.

The Address[7] is ignored and treated as if it were 0.

The section below describes the memory access levels in more detail. The remaining sections in this chapter describe the parameters in the System and Factory regions of the memory map, one 16-byte page at a time.

ams Datasheet Page 43
[v1-10] 2018-Apr-25 Document Feedback



Memory Access Levels

Every address in the memory map is assigned to one of four types of access levels: Application, Measurement, System, and Factory. The properties of each access level are described in this section and shown in Figure 32.

Figure 32: Memory Map

Memory Area	Location	Contents	RFID Access	SPI Access
Application	0x000 -4*APPBLKS[7:0]+3	Application data not logged data	Readable by RFID. Writeable by RFID if Application access has been granted through Set Access	Read/Write by SPI
Measurement	4*APPBLKS[7:0]+4 to 0x3FF	System-level		Read/Write by SPI
System	See Memory Map Layout	•	Readable by RFID. Writeable by RFID if System access has been granted through Set Access	Read/Write by SPI
Factory	See Memory Map Layout	Calibration info, passwords, memory lock bits etc. Examples are UID, real time and system oscillator trim values	Lock bits can be set but not read through the RF interface using the Lock Block command but otherwise not accessible through the RF interface.	Readable through SPI Writeable through SPI if Factory access is active.

Application Access Region

The Application access region is for application parameters that are protected from data logging. This region begins at byte address 0x000 and ends at byte address 4*APPBLKS[7:0] + 3. This region is readable by both the RFID and SPI memory access commands. It is writeable through RFID only if Application access has been granted through the Set Access command. It is always writeable through the SPI.

Page 44ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Measurement Access Region

The Measurement access region is for data logging. If APPBLKS[7:0] is not 8'd255, this region begins at address 4*APPBLKS[7:0] + 4 and ends at address 0x3FF. (If APPBLKS[7:0] equals 8'd255, there is no Measurement region.) This region is readable by both the RFID and SPI memory access commands. It is writeable through RFID only if Measurement access has been granted through the Set Access command. It is always writeable through the SPI. The logging functions do not need Measurement access in order to write to this region; the Measurement access is only required for direct writing via the RFID interface.

System Access Region

The System access region is for system-level calibration parameters, data pointers, and other control settings. This region is readable by both the RFID and SPI memory access commands. It is writeable through the RFID interface only if System access has been granted through the Set Access command. It is always writeable through the SPI.

There are two sub-regions of System access. The EEPROM region is from address 0x400 through 0x43F. All values in this region are readable and writable with the correct access.

The second sub-region of System access is the mirrored registers. It is for EEPROM parameters that are read and copied into registers at startup. This region is from address 0x600 through 0x63F. All values in this region are write-only (with the correct access). All bytes in this region will read back as 0x00 (with no error).

ams Datasheet Page 45
[v1-10] 2018-Apr-25 Document Feedback



Factory Access Region

The Factory access region is for factory-only calibration parameters and control settings, as well as password storage and memory lock bits. The region is not accessible through the RFID interface. Attempts to write to this region through the RFID interface will generate a password error. Reads through the RFID interface will simply read 0x00 for each byte with no error. The Factory access regions are readable through the SPI, but are only writeable if Factory access is active.

Factory access is made active by writing a special hard-coded Factory access password using the SPI direct command "Factory Access". If Factory access is not open, SPI writes to Factory access area will simply be ignored.

There are three sub-regions of Factory access.

The first sub-region is the EEPROM region from address 0x440 through 0x47F. All values in this region are readable and writable via the SPI with the correct access.

The second sub-region of Factory access is the mirrored registers. It is for EEPROM parameters that are read and copied into registers at startup. This region is from address 0x640 through 0x67F. All values in this region are write-only (with the correct access). All bytes in this region will read back as 0x00 (with no error).

The third sub-region of Factory access is the volatile registers. These registers are used for factory level parameters that are not duplicated in the EEPROM and require access through the memory map. This region goes from address 0x740 through 0x77F. All values are writeable with the correct access. No addresses in this region are readable; they all read back as 0x00 with no error.

The remaining sections in this chapter describe the parameters in the System and Factory regions of the memory map, one 16-byte page at a time.

Page 46

Document Feedback

[v1-10] 2018-Apr-25



System EEPROM

Global System Parameters

The System EEPROM page from addresses 0x400 through 0x40F contains several global use System parameters. All have the standard System level access through RFID and SPI.

Figure 33: Global System Parameters

Addr.	RFID Block				Bit							
Addr.		7	6	5	4	3	2	1		0		
0x400			STIME[7:0]									
0x401	0x00		STIME[15:6]									
0x402	UX00		STIME[23:16]									
0x403					STIME[31:	:24]						
0x404			DSFID[7:0]									
0x405	0x01		AFI[7:0]									
0x406		APPBLKS[7:0]										
0x407												
0x408					LOGDEL[7	7:0]						
0x409	0x02						LO	GDEL[11	:8]			
0x40A	0.002				LOGINT[7	7:0]						
0x40B		LOGINT[15:8]										
0x40C		MEASCNT[7:0]										
0x40D	0x03				MEASCNT[15:8]						
0x40E	UXUS	SKIP16	STRMD									
0x40F												

STIME[31:0] – Start time. This 32-bit value can be used to mark the start time for logging. It is not used internally by the AS39513, so its format can be application dependent.

DSFID[7:0] – Data storage format identifier. This value is written by the Write DSFID command and read back as part of the Get System Info command.

AFI[7:0] – Application family identifier. This value is written by the Write AFI command and is read back as part of the Get System Info command.

ams Datasheet Page 47
[v1-10] 2018-Apr-25 Document Feedback



APPBLKS[7:0] – Number of four-byte memory blocks in Application memory minus 1. APPBLKS = 255 means 256 Application blocks and no Measurement blocks. APPBLKS = 0 means 1 Application block and 255 Measurement blocks. The measurement logging will begin at address {1'b0, APPBLKS + 1, 2'b00}, assuming APPBLKS < 255.

LOGDEL[11:0] – Logging delay before first logging event. Wait 512*LOGDEL seconds after power-up initialization to begin logging.

LOGINT[15:0] – Logging interval, in seconds, between timer-generated logging events. If LOGINT is set to zero, no logging is performed.

MEASCNT[15:0] – Measurement count. This value is incremented with each logging event, even if the limit thresholds caused the measurements not to be recorded to EEPROM.

STRMD – Storage mode.

0 = Normal logging. When the logging memory is full, additional logging values will be lost.

SKIP16 – Update counts only every 16 measurements.

0 = MEASCNT, MEASPTR, and status byte (0x43B) updated every measurement.

1 = MEASCNT, MEASPTR, and status byte (0x43B) updated every 16 measurements, when MEASCNT[3:0] = 4'b1111.

Page 48
Document Feedback
[v1-10] 2018-Apr-25



Temperature Sensor Parameters

The temperature sensor parameter EEPROM page from addresses 0x410 through 0x41F contains parameters used during temperature logging. All have the standard System level access through RFID and SPI.

Figure 34: Temperature Sensor Parameters

Addr.	RFID				В	Bit					
Addr.	Block	7	6	5	4	3	2	1	0		
0x410					TXHIL	IM[7:0]					
0x411	0x04		TXLOLIM[7:0]								
0x412			THILIM[7:0]								
0x413					TLOLI	M[7:0]					
0x414					TXHIC	NT[7:0]					
0x415	0x05				TXLOC	NT[7:0]					
0x416	0.003	THICNT[7:0]									
0x417		TLOCNT[7:0]									
0x418					THIMA	λX[7:0]					
0x419	0x06	TLOMAX[7:0]									
0x41A	0,000										
0x41B											
0x41C											
0x41D	0x07										
0x41E	0.07										
0x41F											

TXHILIM[7:0] – First threshold to use for limit checks during temperature measurements. See the section on Limit Check Algorithm above.

TXLOLIM[7:0] – Second threshold to use for limit checks during temperature measurements. See the section on Limit Check Algorithm above.

THILIM[7:0] – Third threshold to use for limit checks during temperature measurements. See the section on Limit Check Algorithm above.

ams Datasheet Page 49
[v1-10] 2018-Apr-25 Document Feedback



TLOLIM[7:0] – Fourth threshold to use for limit checks during temperature measurements. See the section on Limit Check Algorithm above.

TXHICNT[7:0] – Counter for the number of times that the first threshold condition was met during limit checks of the temperature measurement. If this count is non-zero, the over limit count flag, OVLIM, will be set.

TXLOCNT[7:0] – Counter for the number of times that the second threshold condition was met (but not the first condition) during limit checks of the temperature measurement. If this count is non-zero, the over limit count flag, OVLIM, will be set.

THICNT[7:0] – Counter for the number of times that the third threshold condition was met (but not the first or second condition) during limit checks of the temperature measurement.

TLOCNT[7:0] – Counter for the number of times that the fourth threshold condition was met (but not the first, second, or third condition) during limit checks of the temperature measurement.

THIMAX[7:0] – Maximum count for the number of times that the third threshold condition was met (but not the first or second condition) during limit checks of the external sensor measurement. If THICNT > THIMAX, then the over limit count flag, OVLIM, will be set.

TLOMAX[7:0] – Maximum count for the number of times that the fourth threshold condition was met (but not the first, second, or third condition) during limit checks of the external sensor measurement. If TLOCNT > TLOMAX, then the over limit count flag, OVLIM, will be set.

Page 50

Document Feedback

[v1-10] 2018-Apr-25



External Sensor Parameters

The external sensor parameter EEPROM page from addresses 0x420 through 0x42F contains parameters used during external sensor logging. All have the standard System level access through RFID and SPI.

Figure 35: **External Sensor Parameters**

Addr.	RFID				В	it					
Addi.	Block	7	6	5	4	3	2	1	0		
0x420					EXHIL	M[7:0]					
0x421	0x08		EXLOLIM[7:0]								
0x422	0.000				EHILII	M[7:0]					
0x423					ELOLI	M[7:0]					
0x424					EXHIC	NT[7:0]					
0x425	0x09		EXLOCNT[7:0]								
0x426	0,09		EHICNT[7:0]								
0x427		ELOCNT[7:0]									
0x428		EHIMAX[7:0]									
0x429	0x0A	ELOMAX[7:0]									
0x42A	OXOA										
0x42B											
0x42C											
0x42D	0x0B										
0x42E	0.000										
0x42F											

EXHILIM[7:0] – First threshold to use for limit checks during external sensor measurements. See the section on Limit Check Algorithm above.

EXLOLIM[7:0] – Second threshold to use for limit checks during external sensor measurements. See the section on Limit Check Algorithm above.

EHILIM[7:0] – Third threshold to use for limit checks during external sensor measurements. See the section on Limit Check Algorithm above.

ams Datasheet Page 51 **Document Feedback**



ELOLIM[7:0] – Fourth threshold to use for limit checks during external sensor measurements. See the section on Limit Check Algorithm above.

EXHICNT[7:0] – Counter for the number of times that the first threshold condition was met during limit checks of the external sensor measurement. If this count is non-zero, the over limit count flag, OVLIM, will be set.

EXLOCNT[7:0] – Counter for the number of times that the second threshold condition was met (but not the first condition) during limit checks of the external sensor measurement. If this count is non-zero, the over limit count flag, OVLIM, will be set.

EHICNT[7:0] – Counter for the number of times that the third threshold condition was met (but not the first or second condition) during limit checks of the external sensor measurement.

ELOCNT[7:0] – Counter for the number of times that the fourth threshold condition was met (but not the first, second, or third condition) during limit checks of the external sensor measurement.

EHIMAX[7:0] – Maximum count for the number of times that the third threshold condition was met (but not the first or second condition) during limit checks of the external sensor measurement. If EHICNT > EHIMAX, then the over limit count flag, OVLIM, will be set.

ELOMAX[7:0] – Maximum count for the number of times that the fourth threshold condition was met (but not the first, second, or third condition) during limit checks of the external sensor measurement. If ELOCNT > ELOMAX, then the over limit count flag, OVLIM, will be set.

Logging Control Parameters

The logging control parameter EEPROM page from addresses 0x430 through 0x43F contains parameters used during logging and other system controls. All have the standard System level access through RFID and SPI. This page is copied to registers at 0x630 through 0x63F during device initialization. After initialization, if an EEPROM write occurs to these addresses either from the RFID or SPI interface, the corresponding register in the 0x630 through 0x63F page is also updated. In addition, the status byte 0x43D is updated at the end of a logging event.

Page 52

Document Feedback

[v1-10] 2018-Apr-25



Figure 36: Logging Control Parameters

Addr.			Defa	ult Set	tings				RFID				В	it			
Addi.	7	6	5	4	3	2	1	0	0 Block	7	6	5	4	3	2	1	0
0x430	0	1	0								TV1SET[2:0]				TV1TRIM[4:0]		
0x431	0	1	1						0x0C		TV2SET[2:0]				TV2TRIM[4:0]		
0x432									UXUC					TSMOFF[6:0]			
0x433								0									TSV1G
0x434	0	1	0						EV1SET[2:0]					EV1TRIM[4:0]			
0x435	1	0	1						0x0D		EV2SET[2:0]				EV2TRIM[4:0]		
0x436									OXOD					EXMOFF[6:0]			
0x437						0	0	0							EXGAI	N[1:0]	EXV1G
0x438	0	0	0	0	0		0	0		HILIM	LOPOR	ADJUST	CPHLD	OSCEN		TMIEN	TMSRT
0x439	0	0	1	1		0	0	0	0x0E	DOSR	C[1:0]	DOM	D[1:0]		DLOG	DIME	D[1:0]
0x43A			0	0	0	0	1	0	OXOL			BCKSE	EL[1:0]		BTYPE[2:0]		BATCHK
0x43B	0	0	0	0	0	0	0	0		EXCPR	LOGFMT	LOGM	ID[1:0]	EIEN	EXMEAS	BVMEAS	TSMEAS
0x43C	0	0	0	0	0	0	0	0				EXCSET[4:0]			EICUR	EXIVSI	ET[1:0]
0x43D	0	0	0	0	0	0		0	0x0F	ACTIVE	EEFULL	OVWRT	ADCERR	LOWBAT	ACTPOR		OVLIM
0x43E	0	0	0	0	0	0	0	0	0.01		MEASPTR[7:0]			TR[7:0]			
0x43F	0	_			0	0	0	0		WAKEMD					MEASP	TR[11:8]	



TV1TRIM[2:0] – Signed binary value. Trims the ADC reference voltage V1 used during temperature and battery measurements. See the section Analog to Digital Conversion for more details.

TV1SET[2:0] – Reference levels for the ADC during temperature measurements. The condition TV2SET ≥ TV1SET-1 must be fulfilled to ensure the ADC input range V2-V1 is positive.

Note if the temperature range is changed the temperature sensor will need recalibration. See the section Analog to Digital Conversion for more details.

TV2TRIM[2:0] – Signed binary value. Trims the ADC reference voltage V2 used during temperature and battery measurements. See the section Analog to Digital Conversion for more details.

TV2SET[2:0] – Reference levels for the ADC to use during temperature measurements. The condition TV2SET ≥ TV1SET-1 must be fulfilled to ensure the ADC input range V2-V1 is positive. Note if the temperature range is changed the temperature sensor will need recalibration. See the section Analog to Digital Conversion for more details.

TSMOFF[6:0] – Offset to use during temperature and battery measurements. This value is a twos-compliment signed value. It is sign-extended to 10 bits and added to the ADC result after a temperature or battery measurement.

TSV1G – V1 ground setting (trf_gndv1_o) to use during temperature measurements.

EV1TRIM[2:0] – Signed binary value. Trims the ADC reference voltage V1 used during external sensor measurements. See the section Analog to Digital Conversion for more details.

EV1SET[2:0] – Reference levels for the ADC to use during external sensor measurements. The condition EV2SET ≥ EV1SET-1 must be fulfilled to ensure the ADC input range V2-V1 is positive. See the section Analog to Digital Conversion for more details.

EV2TRIM[2:0] – Signed binary value. Trims the ADC reference voltage V2 used during external sensor measurements. See the section Analog to Digital Conversion for more details.

EV2SET[2:0] – Reference levels for the ADC to use during external sensor measurements. The condition EV2SET ≥ EV1SET-1 must be fulfilled to ensure the ADC input range V2-V1 is positive. See the section Analog to Digital Conversion for more details.

EXMOFF[6:0] – Offset to use during external sensor measurements. This value is a twos-compliment signed value. It is sign-extended to 10-bits and added to the ADC result after an external sensor measurement.

EXV1G – V1 ground setting (trf_gndv1_o) to use during external sensor measurements.

EXGAIN[1:0] – Multiplexer gain setting (mux_gain_o) to use during external sensor measurements.

Page 54

Document Feedback

[v1-10] 2018-Apr-25



TMSRT – Use delay timer (with LOGDEL) to transition from WAIT mode to ACTIVE mode.

0 = Do not use delay timer. If DIMD is not 2'b10, WAIT mode transitions directly to ACTIVE mode with no delay.

1 = Use the delay timer. If DIMD is 2'b10, the event that happens first (delay or DIN input) causes the transition from WAIT mode to ACTIVE mode.

TMIEN – Timer interrupt enable.

0 = No timer generated logging events.

1 = Generate logging events with the LOGINT delay.

OSCEN – Real-time oscillator enable. The real-time oscillator must be enabled for any of the real-time delays above to be of use. It can be disabled to further reduce power consumption in applications that do not need timing based interrupts or log time tracking.

0 = Disable real-time oscillator.

1 = Enable real-time oscillator.

CPHLD – Enable charge-pump hold feature of the sensor charge pump.

0 = Disable charge-pump hold.

1 = Enable charge-pump hold.

ADJUST – Adjust logging information to an even byte boundary after logging.

0 = No adjustment. Logging information is maximally packed in spite of byte boundaries.

1 = Each logging event ends at a byte boundary. Only values within the same logging event are packed.

LOPOR - Control RF POR threshold.

0 = Use default higher POR threshold.

1 = Use lower POR threshold.

HILIM - Control RF limiter threshold.

0 = Use default lower limiter threshold.

1 = Use higher limiter threshold.

ams Datasheet Page 55
[v1-10] 2018-Apr-25 Document Feedback



DIMD[1:0] – Input mode for DIN pin (when not in SPI communication).

2'b00 = CMOS input, non-inverting 100k ohm pull down to ground enabled.

2'b01 = Digital sensor input with pull up. Pull-up current is supplied to DIN only during a logging event.

2'b10 = Use the DIN pin for startup. When in the WAIT state, a pull-up current is supplied to DIN. A falling edge on DIN manually causes a transition from WAIT mode to ACTIVE mode. If TMSRT is also 1, the event that happens first (delay or DIN input) causes the transition from WAIT mode to ACTIVE mode.

2'b11 = Use the DIN pin for a logging interrupt. During ACTIVE mode, a pull-up current is supplied to DIN. A falling edge on DIN generates a logging event.

DLOG – Add the digital input and external sensor interrupt values to the data that is logged. The two-bit value { din_i, extirq i } is added to the logging data.

0 = No status logging of the digital input and external sensor interrupt.

1 = Add logging of the digital input and external sensor interrupt.

DOMD[1:0] – Digital output mode (when not in SPI communication).

2'b00 = CMOS (push-pull) output.

2'b01 = Pull-up output.

2'b10 = Pull-down output. DOUT is inverted relative to DOSRC description below.

2'b11 = High impedance (disconnected) output. Default.

DOSRC[1:0] – Digital output source (when not in SPI communication).

2'b00 = DOUT is a copy of the external interrupt comparator output.

2'b01 = DOUT is high when an ISO 15693 command has been recognized and is being processed.

2'b10 = DOUT is high when the RF field is available.

2'b11 = DOUT is the logical OR of EEFULL, ADCERR, LOWBAT, and OVLIM. If OSCEN=1, the output is AND'd with a modulated signal that is 1/32 second high (32 counts of osc1k) and 31/32 second low (992 counts of osc1k).

BATCHK – Battery check at the start of logging.

0 = No battery check.

1 = Do a battery check in order to qualify the logging.

Page 56

Document Feedback

[v1-10] 2018-Apr-25



BTYPE[2:0] – Battery type algorithm to use.

3'b000 = Battery voltage is assumed to be nominally 1.5 V.

3'b001 = Battery voltage is assumed to be nominally 3.0 V.

If the BTYPE value is changed for example from 3V type to 1.5V type, the new BTYPE value will only take effect after the next power up of the chip. The temperature sensor accuracy is only guaranteed if the chip is operated with a battery corresponding to the BTYPE it was tested with.

BCKSEL[1:0] – Battery compare threshold. Threshold also depends on whether the battery is a 3 V or 1.5 V type as determined by the BTYPE[2:0] above. This is mapped directly to bchk_sel_o. When BTYPE is set for 1.5V batteries, BCKSEL can only have the default value BCKSEL[1:0] = 00. Please see Figure 10 for the battery check threshold values.

TSMEAS – Enable temperature sensor logging.

0 = No temperature measurements.

1 = During logging, temperature measurements are made and optionally recorded depending on the logging mode.

BVMEAS – Enable an ADC measurement of the battery voltage.

0 = No ADC measurement of the battery voltage is made or logged.

1 = Enable ADC measurement and logging of the battery voltage.

EXMEAS – Enable external sensor logging.

0 = No external sensor measurements.

1 = During logging, external sensor measurements are made and optionally recorded depending on the logging mode.

EIEN – Enable external sensor interrupt.

0 = No external sensor interrupt.

1 = External sensor interrupt can trigger a logging event. Interrupt will be triggered when the voltage on the SEXT pin falls below the threshold defined by EXIVSET. Interrupt is falling-edge sensitive, so the SEXT pin must rise above the threshold before an additional sensor interrupt can be triggered.

LOGMD[1:0] – Logging mode for all sensors.

2'b00 – Dense mode. Logging will occur for all logging events. No measurement count or real-time clock values will be logged.

2'b01 – Interrupt mode. Logging will occur for all logging events. Sensors are always logged to 10-bit accuracy. The real-time clock value and interrupt source are logged. The interrupt source is a two-bit value: 2'b01 = external sensor interrupt, and 2'b10 = DIN interrupt.

2'b10 – Normal limit mode. Enable logging if any of the limit check conditions are met. Sensors are always logged to 10-bit accuracy. If a measurement is logged, the value of the measurement counter is also logged.

ams Datasheet Page 57
[v1-10] 2018-Apr-25 Document Feedback



2'b11 – Limit crossing mode. Enable logging only if one of the limit check conditions is different than that from the previous logging event. Sensors are always logged to 10-bit accuracy. If a measurement is logged, the value of the measurement counter is also logged.

LOGFMT – Logging format.

0 = Only the 8 MSB's of the 10-bit ADC result for each measurement are logged. This is only valid when LOGMD = 2'b00. For other values of LOGMD, 10 bits are always used.

1 = All 10 bits of the ADC result for each measurement are logged.

EXCPR – Use compressed format for external sensor.

0 = Uncompressed ADC result used.

1 = An 8-bit compressed version of the 10-bit ADC result is logged. (This is only valid when LOGMD = 2'b00 and LOGFMT = 0.)

The compression algorithm for the result ex_res_ff[9:0] is as follows:

Figure 37: Compression Algorithm

Condition	Compressed Result
ex_res_ff[9] = 1	{ 2'b11, ex_res_ff[8:3] }
ex_res_ff[9:8] = 2'b01	{ 2'b10, ex_res_ff[7:2] }
ex_res_ff[9:7] = 3'b001	{ 2'b01, ex_res_ff[6:1] }
Otherwise	{ 2'b00, ex_res_ff[5:0] }

EXIVSET[1:0] – Voltage threshold for external interrupt. This value is mapped directly to exi_vset_o[1:0]. See the description of the External Sensor Interrupt circuits for more information. The threshold voltages are given in the table below, where vdda is the digital supply voltage.

Page 58

Document Feedback

[v1-10] 2018-Apr-25



Figure 38:
Voltage Threshold for External Interrupt

EXIVSET[1:0]	Voltage Threshold
2′b00	vdda * 0.256
2'b01	vdda * 0.083
2′b10	vdda * 0.355
2′b11	vdda * 0.438

EICUR – Enable the current drive for the external sensor interrupt. This is independent of the EXCSET current source and is only used if EIEN = 1.

0 = Disable external sensor interrupt current.

1 = Enable current drive for external sensor interrupt if EIEN = 1.

EXCSET[4:0] – Current drive select for external sensor measurement. This current is only active during the external sensor measurement. It is not used when the AS39513 is in low power mode waiting for an interrupt or timer event. This value is mapped directly to trf_iset_o[4:0]. See the description of the Trimmed Reference circuit for more information.

OVLIM – Limit count threshold exceeded.

0 = No limit count thresholds exceeded.

1 = One of the eight limit count thresholds have been exceeded.

ACTPOR – Active wakeup after power-up reset.

0 = The AS39513 has not had a reset direct to ACTIVE mode

1 = The AS39513 has had a power on reset occur when WAKEMD = 1 and ACTIVE = 1.

LOWBAT – Low battery condition.

0 = No low battery condition measured.

1 = The battery check operation (BATCHK = 1) resulted in a low battery indication.

ADCERR - ADC error flag.

ADCERR is a flag in system EEPROM which is set by an under or overflow of the ADC during logging measurements. Once set it remains set until the system EEPROM bit is cleared by a write command to system EEPROM memory. The ADCERR flag is not set by an ADC under or overflow during a Do Measurement command.

0 = No ADC error has occurred.

1 = An ADC error has occurred, either from an input signal out of range or a poorly chosen combination of reference voltage settings.

ams Datasheet Page 59
[v1-10] 2018-Apr-25 Document Feedback



OVWRT – Measurement overwrite flag.

0 = No measurements have been overwritten.

1 = At least one measurement has been overwritten.

EEFULL – The EEPROM is full.

0 = More measurements can be logged.

1 = At least one measurement was not logged due to a lack of EEPROM space.

ACTIVE – Controller state.

0 = Controller is in the IDLE or WAIT modes.

1 = Controller is in the ACTIVE mode.

MEASPTR[11:0] – Measurement pointer. The EEPROM value is the pointer value at the end of a logging operation. The register copy of this measurement pointer will also be updated with each EEPROM write during logging so that it always points to the next logging location. The upper 10 bits of this 12-bit value is the address in the Application and Measurement EEPROM area to which to write. The two LSB's represent the current bit position. The logging values are all 2, 6, 8, or 10-bit values, so they will always fall on one of the four two-bit boundaries in a byte.

WAKEMD – Wakeup mode.

0 = The AS39513 always reinitializes after a power-up reset but the MEASCNT and MEASPTR values in EEPROM from any previous data logging will be retained as long as the chip stays in idle mode.

1 = The AS39513 will skip to ACTIVE mode after a power-up reset if ACTIVE = 1.

Page 60

Document Feedback

[v1-10] 2018-Apr-25



Factory EEPROM

Factory Trim and RFID Parameters

The factory trim and RFID parameter EEPROM page from addresses 0x440 through 0x44F contains trim parameters to be loaded during initialization and RFID factory-set parameters. These values cannot be accessed through the RFID interface unless noted in the field descriptions below. They can be read through the SPI interface. They can be written through the SPI interface if the Factory access password has been entered previously using an SPI direct command. Bytes 0x440 through 0x443 are copied to registers at 0x640 through 0x643 during device initialization. After initialization, if an SPI EEPROM write occurs to the addresses 0x440 through 0x443, the corresponding register in the 0x640 through 0x643 address range is also updated.

Figure 39: Factory Trim and RFID Parameters

Addr.	Bit									
Addi.	7	6	5	4	3	2	1	0		
0x440				OSCTR	IM[7:0]					
0x441	LKALL					ROSTRIM[4:0)]			
0x442						VOTRIM[4:0]				
0x443						TSENTF	RIM[3:0]			
0x444										
0x445										
0x446							AFI_LK	DSF_LK		
0x447				CHIPR	EV[7:0]					
0x448				UID	[7:0]					
0x449				UID[15:8]					
0x44A				UID[2	23:16]					
0x44B				UID[3	31:24]					
0x44C				UID[3	39:32]					
0x44D		UID[47:40]								
0x44E				UID[5	55:48]					
0x44F				UID[6	53:56]					

ams Datasheet Page 61
[v1-10] 2018-Apr-25 Document Feedback



OSCTRIM[7:0] – Real-time oscillator trim setting. This value is mapped directly to osc_trim_o[7:0]. See the description of the Real-Time Oscillator for more information.

ROSTRIM[7:0] – High-speed ring oscillator trim setting. This value is mapped directly to ros_trim_o[4:0]. See the description of the High-Speed Oscillator for more information.

LKALL – Lock all memory. If set, this bit will prevent all Measurement EEPROM from being written directly through RFID commands. Logging events will still be able to write to the Measurement memory.

0 = Lock setting depends on individual block lock bits.

1 = Lock all EEPROM Measurement areas from RFID writes.

VOTRIM[4:0] – Main voltage trim setting for the trimmed reference.

TSENTRIM[3:0] – Temperature sensor bandgap slope trim. This value is mapped directly to tsen_trim_o[3:0]. See the description of the Temperature Sensor for more information.

DSF_LK – Lock the data storage format identifier. This bit can be set through the Lock DSFID command.

0 = The Write DSFID command can change the DSFID value.

1 = The Write DSFID command cannot change the DSFID value.

AFI_LK – Lock the application family identifier. This bit can be set through the Lock AFI command.

0 = The Write AFI command can change the AFI value.

1 = The Write AFI command cannot change the AFI value.

CHIPREV[7:0] – The chip revision identifier. This value can be read through the Get System Info RFID command.

8'h11 = AS39513 v2.0.

UID[63:0] – The unique RFID identifier. This value can be read through the Get System Info RFID command.

Page 62

Document Feedback

[v1-10] 2018-Apr-25



Passwords

The passwords EEPROM page from addresses 0x450 through 0x45F contains the System, Application, and Measurement passwords. The RFID interface can only access these values through the Set Access and Set Password commands described above. They can be read through the SPI interface. They can be $written\,through\,the\,SPI\,interface\,if\,the\,Factory\,access\,password$ has been entered previously.

Figure 40: **Passwords**

Addr.				В	it					
Addr.	7	6	5	4	3	2	1	0		
0x450		SYSPW[7:0]								
0x451				SYSPV	V[15:8]					
0x452				SYSPW	[23:16]					
0x453				SYSPW	[31:24]					
0x454				APPP	W[7:0]					
0x455				APPPV	V[15:8]					
0x456				APPPW	/[23:16]					
0x457				APPPW	/[31:24]					
0x458				MEASF	PW[7:0]					
0x459				MEASP	W[15:8]					
0x45A				MEASPV	V[23:16]					
0x45B				MEASPV	V[31:24]					
0x45C										
0x45D										
0x45E										
0x45F										

SYSPW[31:0] – System access password.

APPPW[31:0] – Application access password.

MEASPW[31:0] – Measurement access password.

ams Datasheet Page 63 **Document Feedback**



Memory Lock Bits

The memory lock bits EEPROM pages from addresses 0x460 through 0x47F contain the individual lock status for each EEPROM block in the Application and Measurement area. As described above, the AS39513 has an 11-bit memory map address space. Let the address space for the Application and Measurement EEPROM be represented by the fields below.

Figure 41: Address Space for the Application and Measurement EEPROM

Bit	10	9	8	7	6	5	4	3	2	1	0
Address	0		AC	ROUP[4	:0]		ABLSB[2:0]			ABYTE	[1:0]

For the Application and Memory areas, Address[10] is always 0. These areas are broken into 256 blocks of four bytes each. The RFID read and write commands work on a block-by-block basis. The 8-bit block address is the concatenation: { AGROUP[4:0], ABLSB[2:0] }. Each block can be individually locked from writing via the RFID write commands by setting one of the memory lock bits in the EEPROM. The EEPROM address containing the memory lock bit for a given block is at the address 0x460 + AGROUP. The bit index to lock the block is ABLSB. For example to lock the block containing the memory address 0x13A, for which AGROUP = 5'b01001, ABLSB = 3'b110, and ABYTE = 2'b10, the RFID Lock Block command writes a 1 to bit 6 in EEPROM address 0x469. The RFID Write Block command must check that the corresponding lock bit is not set before writing to that block.

The RFID interface can only access the memory lock bits through the Lock Block command described above. They can be read through the SPI interface. They can be written through the SPI interface if the Factory access password has been entered previously.

Page 64

Document Feedback

[v1-10] 2018-Apr-25



System Registers

Mirrored System Registers

The addresses 0x630 through 0x63F access registers whose values are copied from the EEPROM addresses 0x430 through 043F during device initialization. After initialization, if an EEPROM write occurs to one or more system EEPROM blocks in the addresses 0x430 through 0x43F, either from the RFID or SPI interface, all the system registers in the 0x630 through 0x63F page are also updated.

The mirrored system register values cannot be accessed directly through the RFID interface. They can be written directly through the SPI interface. Writing directly to the address locations 0x630 through 0x63F only changes the register value; it does not change the EEPROM value. It is intended that the register values will be changed directly during system or factory calibration, and then the final values will be written into EEPROM when the calibration is complete. These registers cannot be read. Reading bytes from these address locations just returns 0x00.

Figure 42: Mirrored System Registers

Addr.					Bit				
Auui.	7	6	5	4	1	3	2	1	0
0x630	-	TV1SET[2:0]				TV1TR	IM[4:0]		
0x631	-	TV2SET[2:0]	TV2TRIM[4:0]						
0x632					TSMO	FF[6:0]			
0x633									TSV1G
0x634		EV1SET[2:0]				EV1TR	IM[4:0]		
0x635		EV2SET[2:0]				EV2TR	IM[4:0]		
0x636					EXMO	FF[6:0]			
0x637							EXGA	IN[1:0]	EXV1G
0x638	HILIM	LOPOR	ADJUST	СРЬ	HLD	OSCEN		TMIEN	TMSRT
0x639	DOSR	C[1:0]		DOMD[1:0]			DLOG	DIME	0[1:0]
0x63A				BCKSEL[1:0]			BTYPE[2:0]		BATCHK
0x63B	EXCPR	LOGFMT		LOGMD[1:0]			EXMEAS	BVMEAS	TSMEAS
0x63C			EXCSE	T[4:0]			EICUR	EXIVSE	T[1:0]
0x63D	ACTIVE	EEFULL	OV	WRT	ADCERR	LOWBAT	ACTPOR		OVLIM
0x63E				N	IEASPTR[7:0]			

ams Datasheet Page 65
[v1-10] 2018-Apr-25 Document Feedback



Addr.		Bit								
Addi.	7	6	5	4	3	2	1	0		
0x63F	WAKEMD					MEASP ⁻	TR[11:8]			

For descriptions of all of these parameters, see Logging Control Parameters.

Factory Registers

Mirrored Factory Registers

The addresses 0x640 through 0x643 access registers whose values are copied from the EEPROM addresses 0x440 through 0443 during device initialization. After initialization, if an EEPROM write occurs to the addresses 0x440 through 0x443, the corresponding register in the 0x640 through 0x643 address range is also updated.

The mirrored factory register values cannot be accessed directly through the RFID interface. They can also be written through the SPI interface if Factory access is open. Writing to the address locations 0x640 through 0x643 only changes the register value; it does not change the EEPROM value. It is intended that the register values will be changed directly during factory calibration, and then the final values will be written into EEPROM when the calibration is complete. These registers cannot be read. Reading bytes from these address locations just returns 0x00.

Figure 43: Mirrored Factory Registers

Addr.	Bit								
Addi.	7	6	5	4	3	2	1	0	
0x640		OSCTRIM[7:0]							
0x641	LKALL				ſ	ROSTRIM[4:0]		
0x642				V0TRIM[4:0]					
0x643				TSENTRIM[3:0]					

For descriptions of all of these parameters, see Factory Trim and RFID Parameters.

Page 66

Document Feedback

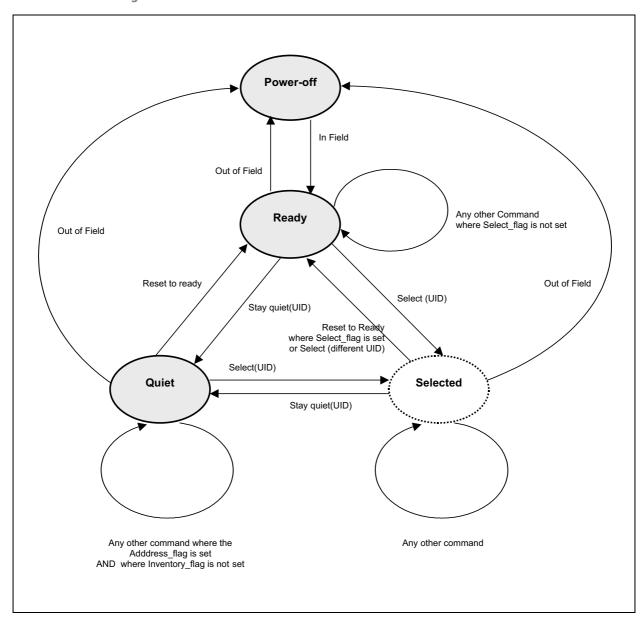
[v1-10] 2018-Apr-25



RFID Commands

All of the RFID commands for the AS39513 follow the standard ISO15693 format. In general, each command has a request and a response. When powered, the RFID interface has three possible states: ready, quiet, and selected, as specified in the ISO15693 standard.

Figure 44: ISO15693 State Diagram



Note(s):

1. Duplicate of ISO15693-3 selected state diagram

ams Datasheet Page 67
[v1-10] 2018-Apr-25 Document Feedback



Request Command Structure

The Request Command Structure from the Reader is:

SOF	Flags	Command Code	UID	Parameters	Data	CRC	EOF
	8 bits	8 bits	64 bits	n*8 bits	m*8 bits	16 bits	

where SOF is the ISO15693 start-of-frame, the Flags are the protocol control flags described below, the command code determines which command is being requested, UID is the unique identifier, parameters and data are zero or more bytes depending on the command, the CRC is the error check code, which is calculated in accordance with ISO15693-3 and EOF is the ISO15693 end-of-frame. The UID can be present or not present depending on the Flags settings.

For the custom commands (command codes 0xA0 through 0xDF), the command code field will be followed immediately by an IC manufacturing code, which for the AS39513 is 0x36 for legacy reasons.

Flags

There are two types of request command flags used in ISO15693: inventory flags (abbreviated IFLAGS) and non-inventory flags (abbreviated NFLAGS). Their formats are as follows.

The Inventory Flags are:

Bit	7	6	5	4	3	2	1	0
IFLAGS	0	OPTION	NBSLOTS	AFI	0	1	DRATE	SUBCAR

where:

SUBCAR – Sub-carrier selection.

0 = Use a single sub-carrier frequency in the response.

1 = Use two sub-carriers in the response.

DRATE – Data rate selection.

0 = Use low data rate.

1 = Use high data rate.

AFI – AFI field usage. Only 0 (no AFI field) is supported in the AS39513.

NBSLOTS – Number of anti-collision slots.

0 = 16 slots.

Page 68ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Inventory Command Flags

Figure 45: **Inventory Command Flags**

Flag Bits	Flag Name	Bit Value	Meaning
i lag bits	i lag Nallie	0	1
b0	SUBCAR	Single	Double
b1	DRATE	Low	High
b2	Inventory	Х	1 for inventory
b3	Protocol ext.	Always 0	RFU
b4	AFI	Always 0	Not supported
b5	NBSLOTS	16 slots	1 slot
b6	OPTION	Always 0	RFU
b7	RFU	Always 0	RFU

The Non-Inventory Flags are:

Bit	7	6	5	4	3	2	1	0
NFLAGS	0	OPTION	ADDR	SELECT	0	0	DRATE	SUBCAR

where:

SUBCAR – Sub-carrier selection.

0 = Use a single sub-carrier frequency in the response.

1 = Use two sub-carriers in the response.

DRATE - Data rate selection.

0 = Use low data rate.

1 = Use high data rate.

SELECT – Use selected or addressed tag.

0 = Command request will be executed according to the ADDR

1 = Command request will be executed only if the AS39513 RFID interface is in the "select" state. The ADDR bit should be 0, and the UID field is not included in the request.

ADDR – Addressing mode.

0 = Request is not addressed. The UID field is not used. The AS39513 always responds to the request.

1 = Request is address to a specific UID. The UID field is used, and the AS39513 responds only if its UID matches that in the command request.

ams Datasheet Page 69 Document Feedback [v1-10] 2018-Apr-25



OPTION – Command option flag. The meaning of this bit depends on the command. If the command description below does not specify a meaning for this bit, this flag is ignored.

Non-Inventory Command Flags

Figure 46: **Non-Inventory Command Flags**

Flag Bits	Flag Name	Bit Value	Meaning
i lay bits	i lag Name	0	1
b0	SUBCAR	Single	Double
b1	DRATE	Low	High
b2	Inventory	0	Х
b3	Protocol ext.	Always 0	RFU
b4	SELECT	All tags	Selected tag
b5	ADDR	Unaddressed	Addressed
b6	OPTION	Command dependent	Command dependent
b7	RFU	Always 0	RFU

Command Response Structure

The RFID command response structure also follows the standard ISO15693 format.

The Response Structure from the Tag is:

SOF	Flags	Parameters	Data	CRC	EOF
	8 bits	n*8 bits	m*8 bits	16 bits	

where SOF is the ISO15693 start-of-frame, the Flags are the protocol response flags described below, parameters and data are zero or more bytes depending on the command, the CRC is the error check code, and EOF is the ISO15693 end-of-frame.

The Response Flags are:

Bit	7	6	5	4	3	2	1	0
RFLAGS	0	0	0	EXTEN	0	0	0	ERR

Page 70 ams Datasheet [v1-10] 2018-Apr-25



Where:

ERR - Error flag.

0 = No error detected.

1 = Error detected. The normal command response parameters and data will be replaced with an 8-bit error code.

EXTEN – Command extension enabled. This will always be 0 in the AS39513.

When an error occurs, the response parameter and data fields will be replaced with a one-byte error code from the list below.

The Response Structure from Tag in Error case is:

SOF	Flags	Error Code	CRC	EOF
	8 bits	8 bits	16 bits	

Figure 47: **Error Handling**

Error Code	Description
0x01	Command code invalid or not supported.
0x02	Command not recognized; format error.
0x03	Command option not supported.
0x0F	Unknown error.
0x10	The specified block is not available (doesnot exist).
0x11	The specified block is already locked and cannot be locked again.
0x12	The specified block is already locked and cannot be written.
0xA0	Incorrect password or memory access not opened.
0xA2	Battery measurement error.
0xA3	A/D conversion error.
0xA6	EEPROM collision.

ams Datasheet Page 71 **Document Feedback**



The details of the AS39513 commands are given in the sections below.

Inventory Command

Inventory Command Request:

SOF	Flags	Command	Mask Length	Mask Value	CRC	EOF
	IFLAGS	0x01	8 bits	0 to 64 bits	16 bits	

Inventory Command Reply:

SOF	Flags	DSFID	UID	CRC	EOF
	RFLAGS	8 bits	64 bits	16 bits	

After receiving an inventory request, the AS39513 responds with its data storage format identifier (DSFID) and its 64-bit unique identifier (UID), both of which are stored in EEPROM. One slot and multiple slots for anti-collision are supported. The parameters are a mask length, and a mask value. The mask length is one byte, and valid values are 0 to 60 when 16 slots are used and 0 to 64 when 1 slot is used. The length of the mask value is the number of bits specified in the mask length, rounded up to the nearest integer number of bytes, with the MSBs padded with zeros as needed.

The ISO 15693-3 specification, in section 9.2 2 , describes a modulation ignore time (t_{mit}) after the reception of an EOF from the reader. This is the time for which 10% modulation will be ignored after an EOF sequence. Manufacturers vary as to which commands implement this specification and how the ignore time varies by command. In the AS39513, the t_{mit} parameter is only applied to the Inventory command. No modulation masking is used for any of the other commands.

Page 72

Document Feedback

[v1-10] 2018-Apr-25

^{2.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



Stay Quiet Command

Stay Quiet Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS*	0x02	64 bits	16 bits	

There is no response to the stay quiet command. The stay quiet command must be executed in addressed mode (In NFLAGS, SELECT = 0 and ADDR = 1), so the UID is mandatory. After receiving the stay quiet command, the AS39513 will remain in the quiet state until the device is reset, it receives a select request, or it receives a reset to ready request. In the quiet state, the device will not process any command where IFLAGS are used. It will process an addressed request.

Read Block Command

Read Block Command Request:

SOF	Flags	Command	UID	BADDR	CRC	EOF
	NFLAGS	0x20	64 bits	8 bits	16 bits	

Read Block Command Reply:

SOF	Flags	Security Status	Block Data	CRC	EOF
	RFLAGS	8 bits	4*8 bits	16 bits	

The read block command reads four bytes from the EEPROM's Application and Measurement areas. The starting byte address to read is 4*BADDR. If the OPTION flag is 1, a security status is returned. If the OPTION flag is 0, no security status is returned. In either case, the four bytes in the block are returned, lowest address and LSB first.

The security status will be 0x00 if the block is not locked, and 0x01 if the block is locked either through the lock bits or the LKALL flag.

ams Datasheet Page 73 **Document Feedback**



Write Block Command

Write Block Command Request:

SO	F Flags	Command	UID	BADDR	Block Data	CRC	EOF
	NFLAGS	0x21	64 bits	8 bits	4*8 bits	16 bits	

Write Block Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The write block command writes the four bytes of Block Data to the EEPROM's Application and Measurement areas. The starting byte address to write is 4*BADDR. The block data is sent lowest address and LSB first. In order to be written, the access state must allow access to the block being written, and the block must not have been locked.

The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.2³. If the Option flag is set to 1 an error will be sent as the reply.

Lock Block Command

Lock Block Command Request:

SOF	Flags	Command	UID	BADDR	CRC	EOF
	NFLAGS	0x22	64 bits	8 bits	16 bits	

Lock Block Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The lock block command sets the bit in System EEPROM to mark as "read-only" the four-byte block beginning at 4*BADDR. No access passwords need to be set prior to using this command.

The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.3³.

Page 74ams DatasheetDocument Feedback[v1-10] 2018-Apr-25

^{3.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



Read Multiple Blocks Command

Read Multiple Blocks Command Request:

SOF	Flags	Command	UID	BADDR	NUMBLK	CRC	EOF
	NFLAGS	0x23	64 bits	8 bits	8 bits	16 bits	

Read Multiple Blocks Command Reply:

SOF	Flags	Security Status	Block Data	CRC	EOF
	RFLAGS	8 bits	4*8 bits	16 bits	
		Repea	at as needed		

The read multiple blocks command reads multiple four-byte blocks from the EEPROM's Application and Measurement areas. The command reads NUMBLK+1 of blocks of data starting from block number BADDR. If the OPTION flag is 1, a security status is returned. If the OPTION flag is 0, no security status is returned. In either case, the four bytes in each block are returned, lowest address and LSB first.

The security status will be 0x00 if the block is not locked, and 0x01 if the block is locked.

If the last byte to read would have an address that is greater than 0x3FF, error code 0x10 is returned and no data is read.

ams Datasheet Page 75 **Document Feedback**



Select Command

Select Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS	0x25	64 bits	16 bits	

The select command must be executed in addressed mode (In NFLAGS, SELECT = 0 and ADDR = 1), so the UID is mandatory. There are three possible actions for the select command.

1. If the UID in the command is equal to the device UID, the AS39513 will enter the selected state and send the reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

- 2. If the UID in the command is different from the device UID, and the device is in the selected state, the AS39513 will return to the ready state and not send a response.
- 3. If the UID in the command is different from the device UID, and the device is not in the selected state, the AS39513 will remain in its current state (ready or quiet) and not send a response.

Reset-to-Ready Command

Reset-to-Ready Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS	0x26	64 bits	16 bits	

Reset-to-Ready Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The reset-to-ready command takes the RFID state machine out of the quiet state and moves it into the ready state.

Page 76

Document Feedback

[v1-10] 2018-Apr-25



Write AFI Command

Write AFI Command Request:

SOF	Flags	Command	UID	AFI	CRC	EOF
	NFLAGS	0x27	64 bits	8 bits	16 bits	

Write AFI Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The write AFI command writes the one byte application family identifier (AFI) to the EEPROM's System area. In order to be written, the access state must allow access to the System memory, and the AFI must not have been locked.

The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.8⁴.

Lock AFI Command

Lock AFI Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS	0x28	64 bits	16 bits	

Lock AFI Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The lock AFI command sets the bit in System EEPROM, AFI_LK, to mark as "read-only" the one-byte AFI value. No access passwords need to be set prior to using this command.

The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.9⁴.

ams Datasheet Page 77
[v1-10] 2018-Apr-25 Document Feedback

^{4.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



Write DSFID Command

Write DSFID Command Request:

SOF	Flags	Command	UID	DSFID	CRC	EOF
	NFLAGS	0x29	64 bits	8 bits	16 bits	

Write DSFID Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The write DSFID command writes the one byte data storage format identifier (DSFID) to the EEPROM's System area. In order to be written, the access state must allow access to the System memory, and the DSFID must not have been locked.

The OPTION flag controls the response timing according to the ISO 15693 standard, section $10.4.10^5$.

Lock DSFID Command

Lock DSFID Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS	0x2A	64 bits	16 bits	

Lock DSFID Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The lock DSFID command sets the bit in System EEPROM, DSFID_LK, to mark as "read-only" the one-byte DSFID value. No access passwords need to be set prior to using this command.

The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.11⁵.

Page 78ams DatasheetDocument Feedback[v1-10] 2018-Apr-25

^{5.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



Get System Info Command

Get System Info Command Request:

SOF	Flags	Command	UID	CRC	EOF
	NFLAGS	0x2B	64 bits	16 bits	

Get System Info Command Reply:

SOF	Flags	Info	UID	DSFID	AFI	MemSz	CHIPREV	CRC	EOF
	RFLAGS	0x0F	64 bits	8 bits	8 bits	16 bits	8 bits	16 bits	

The system info command returns a number of the system parameters, including the UID, DSFID, AFI, memory size (MemSz), and chip revision (CHIPREV). The memory size is formatted in a two-byte word as shown below.

Memory Size Format

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MemSz	0	0	0		BLOCKSZ[4:0]						В	LOCKO	:NT[7:0)]		

where:

BLOCKCNT[7:0] - Number of memory blocks minus 1. 0xFF indicates 256 blocks, 0x00 indicates 1 block.

BLOCKSZ[4:0] - Block size in bytes minus 1. 0x1F indicates a 32-byte block, 0x00 indicates a 1 byte block.

The chip revision is an 8-bit value that is programmed in the EEPROM in production at the factory.

ams Datasheet Page 79 **Document Feedback**



Set Access Command

Set Access Command Request:

S	OF	Flags	Command	IC Mfg.	UID	Level	Password	CRC	EOF
		NFLAGS	0xA0	0x36	64 bits	8 bits	4*8 bits	16 bits	

Set Access Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The set access command opens a specific type of EEPROM area to be available for writing. Three of the four types of area access can be set with this command: System, Application, and Measurement. (The Factory areas can only be accessed through the SPI, except for limited and specific commands like Set Password and Lock Block.) The access level field, Level, has the format below. Note, it is only necessary to first send a Set Access command before a Write command if the password is non zero for a particular EEPROM area.

Access Level Field

Bit	7	6	5	4	3	2	1	0
Level	0	0	0	0	0	0	ALEV[1:0]	

where:

ALEV[1:0] - Access level.

0 = Not allowed.

1 = System access level.

2 = Application access level.

3 = Measurement access level.

Each access level is independent, and only affects write operations. If the set access command for a given level has the correct 32-bit password, the access for writing to that level is opened. The access remains open until the RF field is removed. (The access will close with the loss of RF field even if the logic is continuously powered by an external battery.)

If the set access command has an incorrect password, an incorrect password error (error code 0xA0) is returned. The default passwords for an unprogrammed device are 0x00000000.

The password values themselves are stored and EEPROM and can be written with the Set Password command below.

Page 80

Document Feedback

[v1-10] 2018-Apr-25



Set Password Command

Set Password Command Request:

SOF	Flags	Command	IC Mfg.	UID	Level	Password	CRC	EOF
	NFLAGS	0xA1	0x36	64 bits	8 bits	4*8 bits	16 bits	

Set Password Command Reply:

SOF	Flags	Access	CRC	EOF
	RFLAGS	8 bits	16 bits	

The Access Level Field Level has the Format Below:

Bit	7	6	5	4	3	2	1	0
Level	0	0	0	0	0	0	ALEV[1:0]	

where:

ALEV[1:0] - Access level.

0 = Not allowed.

1 = System access level.

2 = Application access level.

3 = Measurement access level.

The set password command changes the password for the access level specified in ALEV, but only if the access to that level has been opened by the Set Access command. For example, to write the System password, system access must be allowed. If an attempt is made to set a password for an access level that is not open, the AS39513 will respond with an error code 0xA0.

ams Datasheet Page 81
[v1-10] 2018-Apr-25 Document Feedback



Read System Block Command

Read System Block Command Request:

SOF	Flags	Command	IC Mfg.	UID	BADDR	CRC	EOF
	NFLAGS	0xA2	0x36	64 bits	8 bits	16 bits	

Read System Block Command Reply:

SOF	Flags	Security Status	Block Data	CRC	EOF
	RFLAGS	8 bits	4*8 bits	16 bits	

The read system block command reads four bytes from the EEPROM and register System areas. The starting byte address to read is 0x400 + 4*BADDR. If the OPTION flag is 1, a security status is returned. If the OPTION flag is 0, no security status is returned. In either case, the four bytes in the block are returned, lowest address and LSB first.

The security status will always be 0x00 because the System and Factory areas do not have lock bits.

If the block address BADDR corresponds to a Factory access area, the error code 0x10 (specified block not available) will be returned instead of the block data.

Page 82 ams Datasheet [v1-10] 2018-Apr-25



Write System Block Command

Write System Block Command Request:

SOF	Flags	Command	IC Mfg.	UID	BADDR	Block Data	CRC	EOF
	NFLAGS	0xA3	0x36	64 bits	8 bits	4*8 bits	16 bits	

Write System Block Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The write system block command writes the four bytes of Block Data to the EEPROM and register System areas. The starting byte address to write is 0x400 + 4*BADDR. The block data is sent lowest address and LSB first. In order to be written, the access state must allow access to the block being written.

The OPTION flag controls the response timing according to the ISO 15693 standard for the Write Block command, section $10.4.2^6$. If the Option flag is set to 1 an error will be sent as the reply.

ams Datasheet [v1-10] 2018-Apr-25

Page 83

Document Feedback

^{6.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



Read Multiple System Blocks Command

Read Multiple System Blocks Command Request:

SOF	Flags	Command	IC Mfg.	UID	BADDR	NUMBLK	CRC	EOF
	NFLAGS	0xA4	0x36	64 bits	8 bits	8 bits	16 bits	

Read Multiple System Blocks Command Reply:

SOF	Flags	Security Status	Block Data	CRC	EOF
	RFLAGS	8 bits	4*8 bits	16 bits	

The read multiple blocks command reads multiple four-byte blocks from the EEPROM and register System areas. The starting byte address to read is 0x400 + 4*BADDR. The last byte read will be at the address 0x403 + 4*(BADDR + NUMBLK). If the OPTION flag is 1, a security status is returned. If the OPTION flag is 0, no security status is returned. In either case, the four bytes in each block are returned, lowest address and LSB first.

The security status will always be 0x00 because the System and Factory areas do not have lock bits.

If the block address BADDR corresponds to a Factory access area, the data will simply read back as all zeros with no error.

Page 84ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Lock All Blocks Command

Lock All Blocks Command Request:

SOF	Flags	Command	IC Mfg.	UID	CRC	EOF
	NFLAGS	0xA6	0x36	64 bits	16 bits	

Lock All Blocks Command Reply:

SOF	Flags	CRC	EOF
	RFLAGS	16 bits	

The lock all blocks command sets the LKALL bit in System EEPROM to mark as "read-only" the entire Measurement area of the EEPROM. (The Application area is not locked by this bit.) No access passwords need to be set prior to using this command. The OPTION flag controls the response timing according to the ISO 15693 standard, section 10.4.3⁷.

Set Mode Command

Set Mode Command Request:

SOF	Flags	Command	IC Mfg.	UID	Mode	CRC	EOF
	NFLAGS	0xA8	0x36	64 bits	8 bits	16 bits	

Set Mode Command Reply:

SOF	Flags	CRC	EOF	
	RFLAGS	16 bits		

The Set Mode command can change the mode of the chip directly to ACTIVE mode (where logging events can take place) or initially to a WAIT mode (where there is a programmed delay before entering ACTIVE mode). This is the key command to start logging.

ams DatasheetPage 85[v1-10] 2018-Apr-25Document Feedback

^{7.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



The Set Mode command sets the controller mode according to the value in the Mode parameter. The format of the Mode parameter is below.

Mode Parameter Format

Bit	7	6	5	4	3	2	1	0
Level	0	0	0	0	0	0	CMODE[1:0]	

where:

CMODE[1:0] – New controller mode.

0 = Go to the Idle mode.

1 = Go to the Wait mode.

2 or 3 = Go to the Active mode.

The OPTION flag controls the response timing in a manner similar to the ISO 15693 standard for the Write Block command, section $10.4.2^8$. If OPTION = 0, the change in mode will occur after the EOF in the command request, using the same delay as in 10.4.2. The response will be at the completion of the mode change, which can vary depending on the transition. If OPTION = 1, the response will be immediately after the EOF and it will not wait for the completion of the mode transition.

Do Measurement Command

Do Measurement Command Request:

SOF	Flags	Command	IC Mfg.	UID	Meas	CRC	EOF
	NFLAGS	0xA9	0x36	64 bits	8 bits	16 bits	

Do Measurement Command Reply:

SOF	Flags	ADC	CRC	EOF
	RFLAGS	16 bits	16 bits	

Page 86ams DatasheetDocument Feedback[v1-10] 2018-Apr-25

^{8.} For more information, please refer to the respective section of ISO/IEC 15693-3 specification (second edition, 2009-04-15).



The do measurement command initiates a specific measurement outside the normal logging loop. The command reply will wait for the ADC conversion to complete. The ADC algorithm will use a mode that always takes the same amount of time for a given oscillator clock frequency, independent of the conversion value. The format of the Meas parameter is below.

Measurement Parameter Format

Bit	7	6	5	4	3	2	1	0
Meas	0	0	0	0	0	0	DOME	AS[1:0]

where:

DOMEAS[1:0] – Measurement type to initiate.

0 = Do a temperature measurement.

1 = Do a battery level measurement.

2 = Do a sensor measurement.

3 = Reserved; do not use.

Note the Do Measurement -Temperature command results in some self heating of the chip due to the presence of the RF field from the reader, so temperature accuracy cannot be guaranteed with this command. Temperature sensing is intended to be carried out in logging mode.

The do measurement command returns the 10-bit ADC result, formatted in a two-byte word as shown below,

ADC Result Format

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
ADC	0	0	0	0	0	0				,	ADC_R	ES[9:0]			

where:

ADC_RES[9:0] – ADC measurement result.

An example of a "good" reply is 0x0001AC (where 00 => no error in RFLAGs, and 01AC => ADC data). An ADC error reply is 01A3 (where 01 => error indicated in RFLAGS, A3 => ADC error code)

ams Datasheet Page 87 **Document Feedback**



Get Log Status Command

Get Log Status Command Request:

SOF	Flags	Command	IC Mfg.	UID	CRC	EOF
	NFLAGS	0xAA	0x36	64 bits	16 bits	

Get Log Status Command Reply:

SOF	Flags	Log Stat	CRC	EOF
	RFLAGS	8 bits	16 bits	

The get log status command returns the current value of the status bits, in the format shown below,

Status Bits Format

Bit	7	6	5	4	3	2	1	0
Log Stat	ACTIVE	EEFULL	OVWRT	ADCERR	LOWBAT	ACTPOR	0	OVLIM

where:

OVLIM – Limit count threshold exceeded.

0 = No limit count thresholds exceeded.

1 = One of the eight limit count thresholds have been exceeded.

ACTPOR – Active wakeup after power-up reset.

0 = The AS39513 has not had a reset direct to ACTIVE mode event.

1 = The AS39513 has had a power on reset occur when WAKEMD = 1 and ACTIVE = 1.

LOWBAT – Low battery condition.

0 = No low battery condition measured.

1 = The battery check operation (BATCHK = 1) resulted in a low battery indication.

ADCERR - ADC error flag.

0 = No ADC error has occurred.

1 = An ADC error has occurred, either from an input signal out of range or a poorly chosen combination of reference voltage settings.

OVWRT – Measurement overwrite flag.

0 = No measurements have been overwritten.

1 = At least one measurement has been overwritten.

Page 88ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



EEFULL – The EEPROM is full.

0 = More measurements can be logged.

1 = At least one measurement was not logged due to a lack of EEPROM space.

ACTIVE – Controller state.

0 = Controller is in the IDLE or WAIT modes.

1 = Controller is in the ACTIVE mode.

Security Levels

The security level has mainly to do with what area of memory is being accessed rather than which command is accessing it. See section Memory Access Levels. A couple of columns from the table can be eliminated with the following statements:

- All RFID commands can be used in the IDLE, WAIT, and ACTIVE states, but not during LOGGING or initialization.
- The only command that changes the log controller state is "Set Mode".
- The ISO15693 state (Ready, Quiet, Selected) is independent of the log controller state (IDLE, WAIT, etc.)

Figure 48: Summary of Security Levels

Command	Command Code	Security Level	Definition
Inventory	0x01	None	Tag identification, anticollision.
Stay Quiet	0x02	None	Stop responding; reader is communicating with other tags.
Read Block	0x20	None	Read the requested block from application or measurement memory.
Write Block	0x21	A, M	Write to the requested block in application or measurement memory.
Lock Block	0x22	None	Mark a block in application or measurement memory as read only.
Read Multiple Blocks	0x23	None	Read multiple blocks from the application or measurement memory.
Select	0x25	None	Tag singulation.
Reset to Ready	0x26	None	Move tag out of quiet state.
Write AFI	0x27	S	Write AFI field.
Lock AFI	0x28	None	Prevent further writes to AFI field.
Write DSFID	0x29	S	Write DSFID field.

ams Datasheet Page 89
[v1-10] 2018-Apr-25 Document Feedback



Command	Command Code	Security Level	Definition
Lock DSFID	0x2A	None	Prevent further writes to DSFID field.
Get System Info	0x2B	None	Return RFID system parameters.
Set Access	0xA0	None	Enable application, measurement, or system access with correct password.
Set Password	0xA1	A, M, S	Write a new password.
Read System Block	0xA2	None	Read the requested block from system memory.
Write System Block	0xA3	S	Write to the requested block in system memory.
Read Multiple System Blocks	0xA4	None	Read multiple blocks from the system memory.
Lock All Blocks	0xA6	None	Mark all measurement blocks as read only.
Do Measurement	0xA9	None	Do an ADC measurement of one of the sensors.
Set Mode	0xA8	None	Change the controller state.
Get Log Status	0xAA	None	Read the log controller status flags.

The access security levels are:

A = Application access required to access application area of EEPROM.

 $\mathbf{M} = \text{Measurement}$ access required to access measurement area of EEPROM.

S = System access required to access system area of EEPROM.

Figure 49: Security Levels

Security Level	Password	Access
None	No	All open
S	System Password	System area
А	Application Password	Application area
М	Measurement Password	Measurement area

Page 90ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



SPI Commands

The AS39513 has a serial peripheral interface (SPI) bus that enable full and unlimited EEPROM access. Its primary purpose is production calibration and UID programming, but it could also be used by an application to configure the chip during device test.

The SPI bus uses four digital signals. Three of these signals are inputs: CE (SPI chip enable), SCLK (SPI clock), and DIN (SPI data input). One is an output: DOUT (SPI data output). The CE signal enables the SPI interface when high. (When CE is low, the DIN/DOUT pins are used by other application functions unless the SPI direct command "Set IO Mode" has locked the device in SPI mode). The CE input includes an R_D=100k ohm pull down to ground. If driven externally the CE pin should have a 1nF capacitor connected to ground. The SCLK is used to control the timing of the output data and determine when to capture the input data. The maximum SCLK clock frequency f_{SLCK} is 100kHz. The SCLK input includes an $R_D = 100k$ ohm pull down to ground. DIN data is captured on the falling edge of SCLK. DOUT data will change on the rising edge of SCLK. The DIN input can be configured to have an R_D=100k ohm pull down to ground or R_U=30k ohm pull up resistor. See DIMD[1:0].

When CE is set high, a delay time is needed to allow the on-chip high-speed clock and the digital supply regulators to wake up. (If the device is locked in SPI mode through the "Set IO Mode" direct command, this delay is much shorter since the high-speed clock and regulators remain active.) The SPI interface also needs to check that DOUT is low. If DOUT is high, this is a busy signal that indicates that the interface is not ready to receive SPI commands.

Once there has been sufficient delay and DOUT is low, the command and any additional input data are clocked in, MSB first, using SCLK and DIN. For commands with a response, the DOUT pin will go high to indicate data is ready, and then SCLK pulses are used to clock out the data on DOUT. For write commands, DOUT pin acts as a memory busy indicator, going high while the write is in progress.

Commands are not intended to be chained, that is, CE is expected to go low after each command. If a command requires additional processing time after CE goes low, such as an EEPROM write, the processing continues and the regulators and high-speed clock are not shut down until the command is processed.

All SPI commands and data are grouped along 8-bit byte boundaries. There are three types of commands: write commands, read commands, and direct commands. The two MSBs in the 8 or 16-bit command word selects the command type. Each command type is described below.

ams Datasheet Page 91 **Document Feedback**



Write Command

The write command is used to write to both EEPROM and on-chip registers that are memory mapped.

The Write Command Format is below:

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Write	0	0	0	0	0					AD	DR[10	:0]				

where:

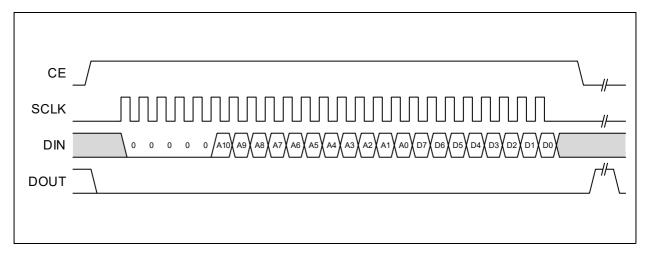
ADDR[10:0] – Address of the memory to write to. See the description of the memory map below for details on what is mapped to the various memory addresses.

The write command word will be followed by one or more bytes of data. The first byte will be written to address ADDR, the second at ADDR+1, and so on. Note that the EEPROM architecture can only write to one 16-byte page at a time. Care must be taken to limit the number of data bytes in the Write Command such that the page boundary is not passed. Specifically, the number of data bytes must be less than or equal to 16 – ADDR[3:0]. If the number of bytes written would go beyond the page boundary at address { ADDR[10:4], 4'b1111 }, then the address counter will effectively wrap around to the start of the page boundary at { ADDR[10:4], 4'b0000 } and overwrite bytes at the start of the page.

The actual write operation is initiated by setting CE low. The DOUT pin will go high when the write is beginning. If SPI mode has been enabled via the direct command "Set IO Mode", the DOUT pin will go low when the write is complete. (If the SPI mode direct command has not set the device to stay in SPI mode, the DOUT pin will revert to its non-SPI mode value when the write is complete.)

As example, the signals for a one-byte write are shown below.

Figure 50: One-Byte Write



Page 92

Document Feedback

[v1-10] 2018-Apr-25



Read Command

The read command is used to read from both EEPROM and on-chip registers that are memory mapped.

The Read Command Format is below:

Bit	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	1	0	0	0					AD	DR[10):0]				

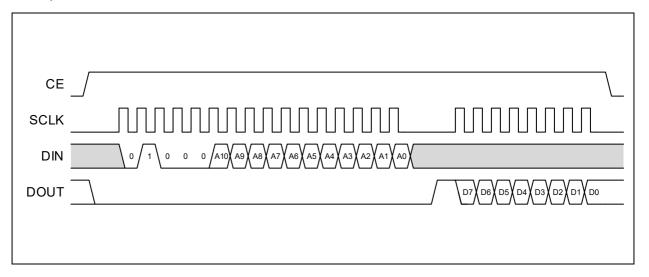
where:

ADDR[10:0] – Address of the memory to read from. See the description of the memory map below for details on what is mapped to the various memory addresses.

After the read command word is complete, DOUT will go high when the read operation is ready. SCLK should then be pulsed 8 times for each byte of data, and the data will be output on DOUT. The output data will be stable on the falling edge of SCLK. The first byte will be read from ADDR, the second byte from ADDR+1, and so on. There is no limit to the number of bytes that can be read. For example, the signals for a one-byte read are shown below. The read operation is completed when CE goes low.

As example, the signals for a one-byte read are shown below.

Figure 51: One-Byte Read



ams Datasheet
Page 93
[v1-10] 2018-Apr-25
Document Feedback



Direct Commands

The direct commands are used for operations that are not directly related or conveniently mapped to the memory.

The Direct Command Format is below:

Bit	7	6	5	4	3	2	1	0
Direct Command	1	1		DCOM[2:0]		С	DPARAM[2:0	[[

where:

DCOM[2:0] – Direct command index. See the table below.

DPARAM[2:0] – Direct command parameter. Its use is command dependent as described in the table below.

The direct commands that are available are listed in the table below.

Figure 52:
Direct Commands

DCOM	Command	Description
3'b000	Reset	Create a master reset pulse that, like a POR, will reset all internal registers and cause the calibrations registers to be loaded from EEPROM. The DOUT signal will go high when the reset takes effect and will remain high while the calibration registers are loaded. This is implemented by generating a rising edge on the trig_rst input to the AFE.
3'b001	Set IO Mode	Force the digital I/O into a fixed state. The I/O will remain in that state until a reset or changed by another command. The I/O state is set by DPARAM, with the following values: 3'b000 = Application mode. 3'b001 = SPI mode. (Also forces 1.92 MHz clock to stay running.) 3'b010 = Scan mode (requires factory access).
3'b010	Read Hardware ID	Reads the one-byte hard-coded hardware identifier. DPARAM is ignored. The following identifiers are defined: 8'h11 = AS39513 version 2.0.
3'b100	Set Mode	Duplicates the functionality of the RFID Set Mode command. (See that command for more details.) The CMODE[1:0] parameter for the Set Mode command is taken from DPARAM[1:0].

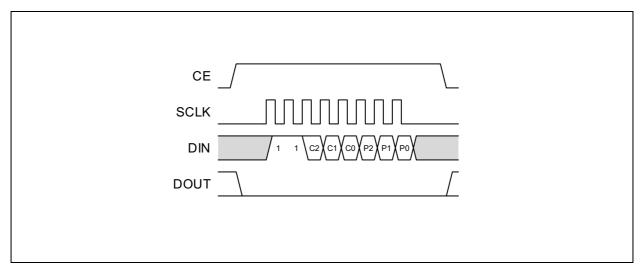
Page 94ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



DCOM	Command	Description
3'b110	Do Measurement	Duplicates the functionality of the RFID Do Measurement command. (See that command for more details.) Before sending this Direct command it is necessary to send a Reset Direct command via SPI. The DOMEAS[1:0] parameter for the Do Measurement command is taken from DPARAM[1:0]. The response is the same 16-bit format as the RFID Do Measurement command, unless there is an ADC error. In the case of an ADC error, 16'hA300 is returned. Note if TV2SET <tv1set-1 0x0000="" 0xa300="" a="" adc="" being="" case.<="" code="" command="" configuration,="" do="" error="" in="" is="" measurement="" not="" particular="" read;="" result="" returned="" spi="" td="" the="" this="" valid="" via="" which="" will=""></tv1set-1>
3′b111	Get Log Status	Duplicates the functionality of the RFID Get Log Status command. (See that command for more details.) The response is the same 8-bit format as the RFID Get Log Status command.

For direct commands that do not have a response, the signals are as illustrated below.

Figure 53:
Direct Commands Without Response

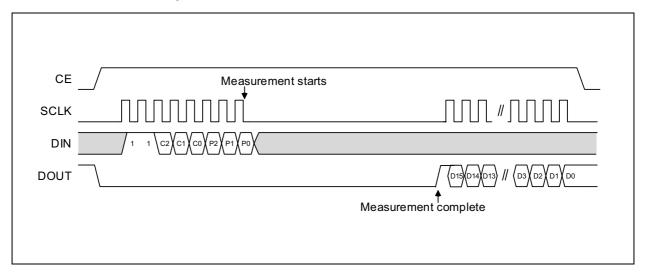


When a direct command has a response, the signaling is similar to the Read command, as shown below.

ams DatasheetPage 95[v1-10] 2018-Apr-25Document Feedback



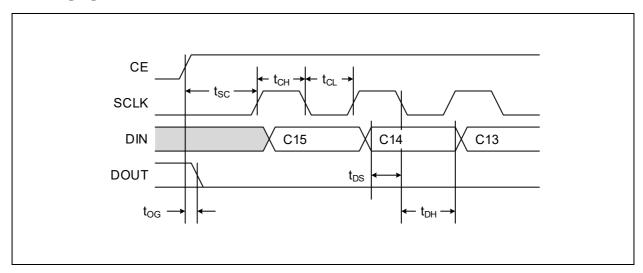
Figure 54:
Direct Commands with Response



SPI Timing

This sections provides more details on the timing relationships and requirements for the SPI interface. The timing for the beginning of a command is independent of the command type, and is as shown below.

Figure 55: SPI Timing Signals



Page 96ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Where the timing parameters are as follows:

Figure 56:
Timing Parameters, VBAT = 3V or 1.5V (unless otherwise noted)

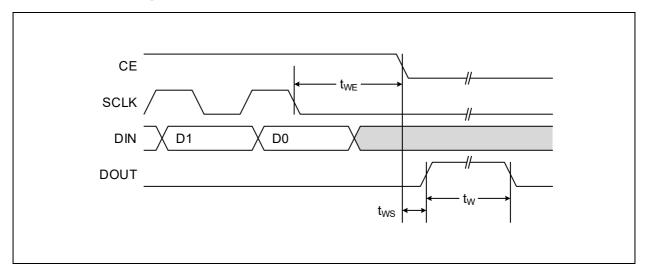
Symbol	Description	Min	Max	Unit
t _{SC}	CE to first SCLK rising edge setup time (1)	150		μs
t _{SC}	CE to first SCLK rising edge setup time, VBAT = $1.5V^{(2)}$	2.0 ⁽³⁾		μs
t _{OG}	DOUT valid time		50	ns
t _{CH}	SCLK high period	5		ms
t _{CL}	SCLK low period	5		ms
t _{DS}	DIN data setup time	50		ns
t _{DH}	DIN data hold time	50		ns

Note(s):

- 1. When the digital interface was not already in SPI mode.
- 2. When the digital interface has been locked into SPI mode.
- 3. t_{SC} reduces to 0.4 μ s @ VBAT=3V

The write command initiates a write with the falling edge of CE. If the interface is locked in SPI mode, the write processing status is indicated by a pulse on DOUT. This timing detail is shown below.

Figure 57: Write Command Timing Detail



ams Datasheet Page 97
[v1-10] 2018-Apr-25 Document Feedback



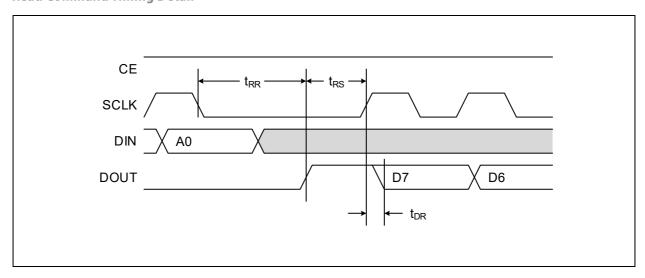
Where the timing parameters are as follows:

Figure 58: Write Command Timing Parameters

Symbol	Description	VBAT :	= 1.5 V	VBAT :	Unit	
Syllibol	Description	Min	Max	Min	Max	
t _{WE}	Falling edge of SCLK to write enable (falling edge of CE).	2.0		2.0		μs
t _{WS}	Write enable to beginning of write processing.		200		200	ns
t _W	Processing time for writes.	6	14	6	14	ms

The read command has two more timing sections of interest. The first is the transition from the command at DIN to the read-back data at DOUT. That timing is shown below.

Figure 59: Read Command Timing Detail



Where the timing parameters are:

Figure 60: Read Command Timing Parameters

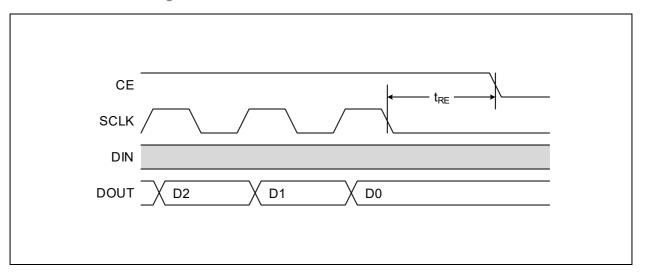
Symbol	Description	VBAT :	= 1.5 V	VBAT :	Unit	
Symbol	Description	Min	Max	Min	Max	Onic
t _{RR}	Falling edge of SCLK to read ready time		4.0		4.0	μs
t _{RR} + t _{RS}	Falling edge of SCLK to read ready on DOUT to SCLK rising edge	500		500		ns
t _{DR}	SCLK rising edge to valid data	50		50		ns

Page 98ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



The last timing section of interest is the end of the data read-back at DOUT. That timing is shown below.

Figure 61: **Read-Back at DOUT Timing Detail**



Where the timing parameter is:

Figure 62: **Read-Back at DOUT Timing Parameters**

Symbol	Description	VBAT :	= 1.5 V	VBAT :	Unit	
Cymbol	Description	Min	Max	Min	Max	Omic
t _{RE}	Time from falling edge of SCLK to falling edge of CE.	2.0		2.0		μs

For the Direct SPI Command - Do Measurement Temperature the DOUT going high signals the measurement is complete and the measured data can be clocked out.

ams Datasheet Page 99 **Document Feedback**



Figure 63: Direct Command Timing Detail

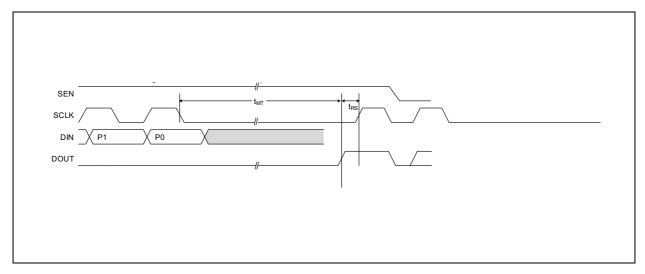


Figure 64:
Direct Command Timing Parameters – Do Measurement Temperature

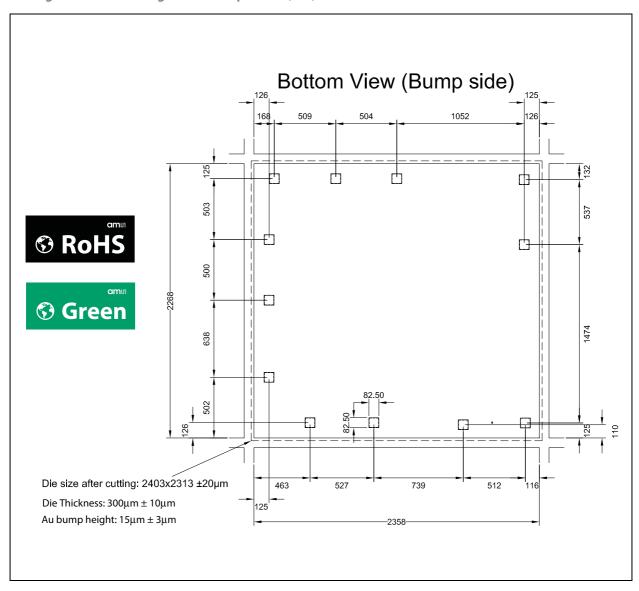
Symbol	Description	VBAT = 1.5V		VBAT= 3.0V		Unit
		Min	Max	Min	Max	Offic
t _{RS}	DOUT rising edge to SCLK rising edge	0		0		ns
t _{MT}	Measurement time SCLK falling edge to DOUT rising edge		6		6	ms

Page 100ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



Package Drawings & Markings

Figure 65:
Package Outline Drawings Gold-Bumped Die (SW)



Note(s):

1. All dimensions are in μm .

ams DatasheetPage 101[v1-10] 2018-Apr-25Document Feedback



Ordering & Contact Information

Figure 66: Ordering Information

Ordering Code	Package	Marking	Delivery Form	Delivery Quantity
AS39513-ZSWF-30	Gold bumped wafer ⁽¹⁾ (3V trimmed)	NA	Sorted and sawn wafer on foil	1 wafer = ca. 3200 good die
AS39513-ZSWF-15	Gold bumped wafer ⁽¹⁾ (1.5V trimmed)	NA	Sorted and sawn wafer on foil	1 wafer = ca. 3200 good die

Ordering Information: Order quantities should be a multiple of shipping form.

Note(s):

 $1. Limited \ quantities \ of gold \ bumped \ die \ are \ also \ available \ as \ engineering \ samples \ in \ waffle \ packs (1 \ waffle \ pack = 50 \ gold \ bumped \ die).$

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Page 102ams DatasheetDocument Feedback[v1-10] 2018-Apr-25



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ams Datasheet Page 103 **Document Feedback**



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Page 104
Document Feedback
[v1-10] 2018-Apr-25



Document Status

Document Status	Product Status	Definition
Product Preview	Pre-Development	Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice
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Page 105 ams Datasheet Document Feedback



Revision Information

Changes from 1-00 (2017-Dec-06) to current revision 1-10 (2018-Apr-25)	Page
Updated Figure 1	1
Updated text under Pin and Pad Layout	4
Updated Figure 4	4
Updated Figure 5	6
Updated Figure 6	8
Updated Figure 7	10
Updated Figure 8	10
Updated text under Detailed Description	11
Updated text under Power Management	11
Updated text under Energy Harvesting	11
Updated text under Real-Time Clock (RTC)	12
Updated text under Temperature Sensor and External Sensor	13
Updated text under Initializing the Chip	16
Updated text under Battery Check	19
Updated text under Power Modes	24
Updated text under Logging Timer	26
Updated text under ADC Output and Range for Temperature Measurement	37
Updated EQ8 and EQ9 under ADC Output and Range for Battery Measurement	39
Updated text under ADC Output and Range for External Sensor Measurement	39
Updated Figure 30 to DOSRC[1:0]: DOUT Functional Options: Digital Output Source (when not in SPI communication).	41
Updated Figure 36 and parameter BATCHK under it	53
Updated text under Mirrored System Registers	65
Updated text under SPI Commands	91
Updated Figure 65	101
Updated Figure 66	102

Note(s):

- 1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.
- 2. Correction of typographical errors is not explicitly mentioned.

Page 106 ams Datasheet [v1-10] 2018-Apr-25



Content Guide

- 1 General Description
- 1 Key Benefits & Features
- 2 Applications
- 3 Block Diagram
- 4 Pin and Pad Layout
- 4 Pin Description
- 6 Absolute Maximum Ratings
- 8 Electrical Characteristics

11 Detailed Description

- 11 Power Management
- 11 Energy Harvesting
- 11 Analog Front End (AFE)
- 12 Processing and Digital Control
- 12 Slave Serial Interface (SPI-like)
- 12 Real-Time Clock (RTC)
- 13 Temperature Sensor
- 13 External Sensor
- 13 Analog to Digital Converter
- 14 Data Protection
- 15 System Description & Modes of Operation
- 16 Initializing the Chip
- 16 RESET Mode
- 17 IDLE Mode
- 17 WAIT Mode
- 18 ACTIVE Mode
- 18 COMMAND Mode
- 18 LOGGING Mode
- 25 Data Log Functions
- 25 Storage Mode
- 26 Logging Timer
- 26 Delay Time
- 27 Manual Log Start
- 27 Logging Mode Data Formats
- 33 Analog to Digital Conversion
- 34 Reference Voltage Generator
- 35 ADC Scaling
- 37 ADC Output and Range for Temperature Measurement
- 39 ADC Output and Range for Battery Measurement
- 39 ADC Output and Range for External Sensor Measurement
- 40 GPIO
- 42 Memory Map
- 44 Memory Access Levels
- 47 System EEPROM
- 47 Global System Parameters
- 49 Temperature Sensor Parameters
- 51 External Sensor Parameters
- 52 Logging Control Parameters

ams Datasheet Page 107
[v1-10] 2018-Apr-25 Document Feedback



- 61 Factory EEPROM
- 61 Factory Trim and RFID Parameters
- 63 Passwords
- 64 Memory Lock Bits
- 65 System Registers
- 65 Mirrored System Registers
- 66 Factory Registers
- 66 Mirrored Factory Registers
- 67 RFID Commands
- 68 Request Command Structure
- 69 Inventory Command Flags
- 70 Non-Inventory Command Flags
- 70 Command Response Structure
- 72 Inventory Command
- 73 Stay Quiet Command
- 73 Read Block Command
- 74 Write Block Command
- 74 Lock Block Command
- 75 Read Multiple Blocks Command
- 76 Select Command
- 76 Reset-to-Ready Command
- 77 Write AFI Command
- 77 Lock AFI Command
- 78 Write DSFID Command
- 78 Lock DSFID Command
- 79 Get System Info Command
- 80 Set Access Command
- 81 Set Password Command
- 82 Read System Block Command
- 83 Write System Block Command
- 84 Read Multiple System Blocks Command
- 85 Lock All Blocks Command
- 85 Set Mode Command
- 86 Do Measurement Command
- 88 Get Log Status Command
- 89 Security Levels
- 91 SPI Commands
- 92 Write Command
- 93 Read Command
- 94 Direct Commands
- 96 SPI Timing
- 101 Package Drawings & Markings
- 102 Ordering & Contact Information
- 103 RoHS Compliant & ams Green Statement
- 104 Copyrights & Disclaimer
- **105 Document Status**
- 106 Revision Information

Page 108

Document Feedback

[v1-10] 2018-Apr-25



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